- IEEE 802.5 and IBM Token-Ring Network[™] Compatible
- Compatible With TI380FPA FNL PacketBlaster™
- Token-Ring Features
 - 16- or 4-Megabit-per-Second Data Rates
 - Supports up to 18K-Byte Frame Size (16-Mbps Operation Only)
 - Supports Universal-and Local-Network Addressing
 - Early Token-Release Option (16-Mbps Operation Only)
 - Compatible With the TMS38054
- Expandable Local LAN-Subsystem Memory Space up to 2 Megabytes
- Glueless Interface to DRAMs
- High-Performance 16-Bit CPU for Communications-Protocol Processing
- 1- to 16.5-Megabyte-per-Second High-Speed Bus Master DMA Interface
- Low-Cost Host-Slave I/O Interface Option
- Up to 32-Bit Host Address Bus
- Selectable Host System-Bus Options
- Adapter Local-Bus Speed Is Switchable Between 4 MHz and 6 MHz
- 80x8x or 68xxx-Type Bus and Memory Organization
 - 8- or 16-Bit Data Bus on 80x8x Buses
 - Optional Parity Checking

- Dual-Port DMA and Direct I/O Transfers to Host Bus
- Supports 8- or 16-Bit Pseudo-DMA Operation
- Enhanced-Address-Copy-Option (EACO) Interface Supports External Address-Checking Logic for Bridging or External Custom Applications
- Support for Module High-Impedance In-Circuit Testing
- Built-In Real-Time Error Detection
- Bring-Up and Self-Test Diagnostics With Loopback
- Automatic Frame-Buffer Management
- 2- to 33-MHz System-Bus Clock
- Slow-Clock Low-Power Mode
- Single 5-V Supply
- 0.8-µm CMOS Technology
- 250-mA Typical Latch-Up Immunity at 25°C
- ESD Protection Exceeds 2000 V
- 144-Pin Plastic Thin Quad Flat Package (PGE Suffix)
- Operating Temperature Range 0°C to 70°C



Figure 1. Network-Commprocessor Applications Diagram

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pin assignments



NC - No internal connection



description

The TI380C25 is a single-chip network-communications processor (commprocessor) that supports token-ring local area networks (LANs) at data rates of 16 Mbps or 4 Mbps. The TI380C25 conforms to ISO 8802–5/IEEE 802.5–1992 standards and has been verified to be completely IBM Token-Ring Network compatible. By integrating the essential control building blocks needed on a LAN-subsystem card into one device, the TI380C25 ensures that this IBM compatibility is maintained in silicon.

The high degree of integration of the TI380C25 makes it a virtual LAN subsystem on a single chip. Protocol handling, host-system interfacing, memory interfacing, and communications processing are all provided through the TI380C25. To complete LAN-subsystem design, only the network-interface hardware, local memory, and minimal additional components such as PAL[®] devices and crystal oscillators need to be added.

The TI380C25 provides a 32-bit system-memory address reach with a high-speed bus-master DMA interface that supports rapid communications with the host system. In addition, the TI380C25 supports direct I/O and a low-cost 8- or 16-bit pseudo-DMA interface that requires only a chip select to work directly on an 80x8x 8-bit slave I/O interface. Finally, selectable 80x8x or 68xxx-type host-system bus and memory organization add to design flexibility.

The TI380C25 supports addressing for up to 2M bytes of local memory. This expanded memory capacity can improve LAN-subsystem performance by allowing larger blocks of information to be transferred at one time and minimizing the frequency of host LAN-subsystem communications. The support of large local memory is important in applications that require large data transfers (such as graphics or database transfers) and in heavily loaded networks where the extra memory can provide data buffers to store data until it can be processed by the host.

The proprietary CPU used in the TI380C25 allows protocol software to be downloaded into RAM or stored in ROM in the local-memory space. By moving protocols (such as LLC) to the LAN-subsystem, overall system performance is increased. This is accomplished by offloading the processing from the host system to the TI380C25, which can also reduce LAN-subsystem-to-host communications. As other protocol software is developed, greater differentiation of end products with enhanced system performance is possible.

In addition, the TI380C25 includes hardware counters that provide real-time error detection and automatic frame-buffer management. These counters control system-bus retries and burst size, and track host and LAN-subsystem buffer status. Previously, these counters needed to be maintained in software. Integrating them into hardware removes software overhead and improves LAN-subsystem performance.

The TI380C25 implements a TI-patented enhanced-address-copy-option (EACO) interface. This interface supports external address-checking devices, such as the TMS380SRA source-routing accelerator. The TI380C25 has a 128-word external I/O space in its memory to support external address-checker devices and other hardware extensions to the TMS380 architecture.

The major blocks of the TI380C25 include the communications processor (CP), the system interface (SIF), the memory interface (MIF), the protocol handler (PH), the clock generator (CG), and the adapter-support function (ASF), as shown in the functional block diagram.

The TI380C25 is available in a 144-pin plastic thin quad flat package (PGE suffix) and is characterized for operation from 0°C to 70°C.

The TI380C25 has a bus interface to the host system, a bus interface to local memory, and an interface to the physical-layer circuitry. Pin names starting with the letter S attach to the host-system bus, and pin names starting with the letter M attach to the local-memory bus.

PAL[®] is a registered trademark of Advanced Micro Devices, Inc. Other companies also manufacture programmable array logic devices.



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functional block diagram





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Pin Functions						
PIN NAME	NO.	ı/o†	DESCRIPTION			
BTSTRP	42	I	Bootstrap. The value on BTSTRP is loaded into the BOOT bit of the SIFACL register at reset (i.e., when SRESET is asserted or the ARESET bit in the SIFACL register is set) to form a default value. BTSTRP indicates whether chapters 0 and 31 of the memory map are RAM or ROM. If these chapters are RAM, the TI380C25 is denied access to the local-memory bus until the CPHALT bit in the SIFACL register is cleared.			
			 H = Chapters 0 and 31 of local memory are RAM based (see Note 1). L = Chapters 0 and 31 of local memory are ROM based. 			
CLKDIV	38	I	Clock divider select (see Note 2) H = 64-MHz OSCIN for 4-MHz local bus L = 32-MHz OSCIN for 4-MHz local bus or 48-MHz OSCIN for 6-MHz local bus			
EXTINTO EXTINT1 EXTINT2 EXTINT3	32 31 30 29	1/0	Reserved; must be pulled high (see Note 3)			
MACS	132	I	Reserved; must be tied low (see Note 4)			
MADH0 MADH1 MADH2 MADH3 MADH4 MADH5 MADH6 MADH7	15 14 13 12 8 7 6 5	I/O	Local-memory address, data, and status bus — high byte. For the first quarter of the local-memory cycle, these bus lines carry address bits AX4 and A0 to A6; for the second quarter, they carry status bits; and for the third and fourth quarters, they carry data bits 0 to 7. The most significant bit is MADH0 and the least significant bit is MADH7. Memory Cycle 1Q 2Q 3Q 4Q Signal AX4, A0-A6 Status D0-D7 D0-D7			
MADL0 MADL1 MADL2 MADL3 MADL4 MADL5 MADL6 MADL7	28 27 26 25 24 23 22 21	I/O	Local-memory address, data, and status bus — low byte. For the first quarter of the local-memory cycle, these bus lines carry address bits A7 to A14; for the second quarter, they carry address bits AX4 and A0 to A6; and for the third and fourth quarters, they carry data bits 8 to 15. The most significant bit is MADL0 and the least significant bit is MADL7. Memory Cycle 1Q 2Q 3Q 4Q Signal A7-A14 AX4, A0-A6 D8-D15 D8-D15			
MAL	131	0	Memory-address latch. MAL is a strobe signal for sampling the address at the start of the memory cycle; it is used by SRAMs and EPROMs. The full 20-bit word address is valid on MAX0, MAXPH, MAX2, MAXPL, MADH0–MADH7, and MADL0–MADL7. Three 8-bit transparent latches can be used to retain a 20-bit static address throughout the cycle. Rising edge = No signal latching Falling edge = Allows the above address signals to be latched			
MAX0	139	I/O	Falling edge = Allows the above address signals to be latched Local-memory-extended address bit. MAX0 drives AX0 at row-address time and drives A12 at column-address and data-valid times for all cycles. This signal can be latched by MRAS. Driving A12 eases interfacing to a BIA ROM. Memory Cycle 1Q 2Q 3Q 4Q Signal AX0 A12 A12			

 $\dagger I = input, O = output$

NOTES: 1. Pin has an internal pullup device to maintain a high-voltage level when left unconnected (no etch).

2. The TI380FPA and TMS380SRA are currently supported only with the 4-MHz local bus in either CLKDIV state. Expansion to support the 6-MHz local bus is under development.

3. Each pin must be individually tied to V_{CC} with a 1-k Ω pullup resistor.

4. Pin should be connected to ground.



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			Pin Functions (Continued)				
PIN NAME	NO.	ı/o †	DESCRIPTION				
MAX2	140	I/O	Local-memory-extended address bit. MAX2 drives AX2 at row-address time, which can be latched by MRAS and A14 at column-address and data-valid times for all cycles. Driving A14 eases interfacing to a BIA ROM. Memory Cycle 1Q 2Q 3Q 4Q Signal AX2 A14 A14 A14				
МАХРН	16	I/O	Local-memory-extended address and parity — high byte. For the first quarter of a memory cycle, MAXPH carries the extended-address bit AX1; for the second quarter of a memory cycle, it carries the extended-address bit AX0; and for the last half of the memory cycle, it carries the parity bit for the high data byte. Memory Cycle 1Q 2Q 3Q 4Q Signal AX1 AX0 Parity Parity				
MAXPL	20	1/0	Local-memory-extended address and parity — low byte. For the first quarter of a memory cycle, MAXPL carries the extended-address bit AX3; for the second quarter of a memory cycle, it carries extended-address bit AX2; and for the last half of the memory cycle, it carries the parity bit for the low data byte. Memory Cycle 1Q 2Q 3Q 4Q Signal AX3 AX2 Parity Parity				
MBCLK1 MBCLK2	123 124	0	Local-bus clock 1 and local-bus clock 2. MBCLK1 and MBCLK2 are referenced for all local-bus transfers. MBCLK2 lags MBCLK1 by a quarter of a cycle. These clocks operate according to: MBCLK[1:2] OSCIN CLKDIV 8 MHz 64 MHz H 8 MHz 32 MHz L 12 MHz 48 MHz L				
MBEN	4	0	Buffer enable. MBEN enables the bidirectional buffer outputs on the MADH, MAXPH, MAXPL, and MADL buses during the data phase. MBEN is used in conjunction with MDDIR, which selects the buffer output direction. H = Buffer output disabled L = Buffer output enabled				
MBGR	18	I/O	Reserved; must be left unconnected.				
MBIAEN	127	0	 Burned-in address enable. MBIAEN is an output signal used to provide an output enable for the ROM containing the adapter's burned-in address (BIA). H = MBIAEN is driven high for any write accesses to the addresses between >00.0000 and >00.000F, or any accesses (read/write) to any other address. L = MBIAEN is driven low for any read from addresses between >00.0000 and >00.000F. 				
MBRQ	17	I/O	Reserved; must be pulled high (see Note 3).				

 † I = input, O = output NOTE 3: Each pin must be individually tied to V_{CC} with a 1-kΩ pullup resistor.



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Pin Functions (Continued)

PIN	PIN				
NAME	NO.	1/o†	DESCRIPTION		
MCAS	141	0	 Column-address strobe for DRAMs. The column address is valid for the 3/16 of the memory cycle following the row-address portion of the cycle. MCAS is driven low every memory cycle while the column address is valid on MADL0-MADL7, MAXPH, and MAXPL, except when one of the following conditions occurs: 1) When the address accessed is in the BIA ROM (>00.0000 - >00.000F) 2) When the address accessed is in the EPROM memory map (i.e., when the BOOT bit in the SIFACL register is zero and an access is made between >00.0010 - >00.FFFF 		
			 or > 1F.0000 - > 1F.FFFF) 3) When the cycle is a refresh cycle, in which case MCAS is driven at the start of the cycle before MRAS (for DRAMs that have CAS-before-RAS refresh). For DRAMs that do not support CAS-before-RAS refresh, it may be necessary to disable MCAS with MREF during the refresh cycle. 		
MDDIR	138	I/O	Data direction. MDDIR is used as a direction control for bidirectional bus drivers. MDDIR becomes valid before MBEN becomes active. H = TI380C25 memory-bus write		
			L = TI380C25 memory-bus read		
MOE	3	0	Memory output enable. MOE is used to enable the outputs of the DRAM memory during a read cycle. MOE is high for EPROM or BIA ROM read cycles.		
			H = Disable DRAM outputs L = Enable DRAM outputs		
MRAS	143	0	Row-address strobe for DRAMs. The row address lasts for the first 5/16 of the memory cycle. MRAS is driven low every memory cycle while the row address is valid on MADL0–MADL7, MAXPH, and MAXPL for both RAM and ROM cycles. It is also driven low during refresh cycles when the refrest address is valid on MADL0–MADL7.		
MREF	130	0	DRAM refresh cycle in progress. MREF is used to indicate that a DRAM refresh cycle is occurring. It is also used for disabling MCAS to all DRAMs that do not use a CAS-before-RAS refresh.		
			H = DRAM refresh cycle in process L = Not a DRAM refresh cycle		
MRESET	125	0	Memory-bus reset. MRESET is a reset signal generated when either the ARESET bit in the SIFACL register is set or SRESET is asserted. This signal is used for resetting external local-bus glue logic.		
			H = External logic not reset L = External logic reset		
MROMEN	133	0	ROM enable. During the first 5/16 of the memory cycle, $\overline{\text{MROMEN}}$ is used to provide a chip select for ROMs when the BOOT bit of the SIFACL register is zero (i.e., when code is resident in ROM, not RAM). It can be latched by $\overline{\text{MAL}}$. $\overline{\text{MROMEN}}$ goes low for any read from addresses > 00.0010 - >00.FFFF or > 1F.0000 - > 1F.FFFF when the BOOT bit in the SIFACL register is zero. $\overline{\text{MROMEN}}$ stays high for writes to these addresses, accesses of other addresses, or accesses of any address when the BOOT bit is 1. During the final three quarters of the memory cycle, $\overline{\text{MROMEN}}$ outputs the A13 address signal for interfacing to a BIA ROM. This means $\overline{\text{MBIAEN}}$, $MAX0$, $\overline{\text{ROMEN}}$, and $MAX2$ together form a glueless interface for the BIA ROM.		
			H = ROM disabled L = ROM enabled		

 $\dagger I = input, O = output$



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Pin Functions (Continued)

PIN						
NAME	NO.	ı/o†	DESCRIPTION			
MW	142	0	Local-memory write. $\overline{\text{MW}}$ is used to specify a write cycle on the local-memory bus. The data on the MADH0-MADH7 and MADL0-MADL7 buses is valid while $\overline{\text{MW}}$ is low. DRAMs latch data on the falling edge of $\overline{\text{MW}}$, while SRAMs latch data on the rising edge of $\overline{\text{MW}}$. H = Not a local-memory write cycle			
			L = Local-memory write cycle			
NMI	33	I	Nonmaskable interrupt request. NMI must be left unconnected.			
OSCIN	135	I	External oscillator input. OSCIN provides the clock frequency to the TI380C25 for a 4-MHz or 6-MHz internal bus (see Notes 5 and 6). CLKDIV OSCIN H 64 MHz for a 4-MHz local bus L 32 MHz for a 4-MHz local bus or 48 MHz for a 6-MHz local bus			
OSCOUT	122	0	Oscillator output CLKDIV OSCOUT L OSCIN / 4 (if OSCIN = 32 MHz, OSCOUT = 8 MHz; if OSCIN = 48 MHz, OSCOUT = 12 MHz) H OSCIN/8 (if OSCIN = 64 MHz, OSCOUT = 8 MHz)			
PRTYEN	41	I	 Parity <u>enable</u>. The value on PRTYEN is loaded into the PEN bit of the SIFACL register at reset (i.e., when SRESET is asserted or the ARESET bit in the SIFACL register is set) to form a default value. PRTYEN enables parity checking for the local memory. H = Local-memory data bus checked for parity (see Note 1). L = Local-memory data bus not checked for parity. 			
NSELOUT0 NSELOUT1	40 119	0 0	Network selection outputs. NSELOUT0 and NSELOUT1 are controlled by the host through the corresponding bits of the SIFACL register. The value of these bits/signals can be changed only while the TI380C25 is reset. NSELOUT0 NSELOUT1 DESCRIPTION L H 16-Mbps token ring H H 4-Mbps token ring			
SADH0 SADH1 SADH2 SADH3 SADH4 SADH5 SADH6 SADH7	97 96 95 94 93 92 86 85	I/O	System address/data bus — high byte (see Note 1).These lines make up the most significant byte of each address word (32-bit address bus) and data word (16-bit data bus). The most significant bit is SADH0, and the least significant bit is SADH7. Address multiplexing: Bits 31 – 24 and bits 15 – 8 Data multiplexing: Bits 15 – 8			
SADL0 SADL1 SADL2 SADL3 SADL4 SADL5 SADL6 SADL7	76 75 74 70 69 68 67 66	I/O	System address/data bus—low byte (see Note 1). These lines make up the least significant byte of each address word (32-bit address bus) and data word (16-bit data bus). The most significant bit is SADL0 and the least significant bit is SADL7. Address multiplexing: Bits $23 - 16$ and bits $7 - 0$ Data multiplexing: Bits $7 - 0$			

† I = input, O = output
 NOTES: 1. Pin has an internal pullup device to maintain a high-voltage level when left unconnected (no etch).

5. Pin has an expanded input voltage specification.

6. A maximum of two TI380C25 devices can be connected to any one oscillator.



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Pin Functions (Continued)

PIN			DESCRIPTION			
NAME NO. I/O [†]			DESCRIPTION			
SALE	64	ο	System address-latch enable. SALE is the enable pulse used to externally latch the 16 LSBs of the address from the SADH0 – SADH7 and SADL0 – SADL7 buses at the start of the DMA cycle. Systems that implement address parity can also externally latch the parity bits (SPH and SPL) for the latched address.			
SBBSY	50	I	System bus busy. The TI380C25 samples the value on SBBSY during arbitration (see Note 1). The sample has one of two values: H = Not busy. The TI380C25 can become bus master if the grant condition is met. L = Busy. The TI380C25 cannot become bus master.			
SBCLK	65	I	System bus clock. The TI380C25 requires SBCLK to synchronize its bus timings for all DMA transfers. Valid frequencies are 2 MHz–33 MHz.			
		1/0	Intel Mode H = System byte high not enabled (see Note 1) L = System byte high enabled			
SBHE/SRNW	79	1/0	Motorola SRNW is used for system read not write. SRNW serves as a control signal to indicate a read or write cycle. Mode H = Read cycle (see Note 1) L = Write cycle			
SBRLS	49	I	System bus release.SBRLS indicates to the TI380C25 that a higher-priority device requires the system bus. The value on SBRLS is ignored when the TI380C25 is not perfoming DMA. SBRLS is internally synchronized to SBCLK.H=The TI380C25 can hold onto the system bus (see Note 1).L=The TI380C25 should release the system bus upon completion of current DMA cycle. If the DMA transfer is not yet complete, the SIF rearbitrates for the system bus.			
SCS	48	I	System chip select. SCS activates the system interface of the TI380C25 for a DIO read or write. H = Not selected (see Note 1) L = Selected			
SDBEN	80	0	System data-bus enable. SDBEN signals to the external data buffers to begin driving data. SDBEN is activated during both DIO and DMA. H = Keep external data buffers in the high-impedance state L = Cause external data buffers to begin driving data			
SDDIR † I = input, Q = ou	59	0	System data direction. SDDIR provides the external data buffers with a signal indicating the direction the data is moving. During DIO writes and DMA reads, SDDIR is low (data direction is into the TI380C25). During DIO reads and DMA writes, SDDIR is high (data direction is out from the TI380C25). When the system interface is not involved in a DIO or DMA operation, SDDIR is high by default. DATA SDDIR DIRECTION DIO DMA H output read write L input write read			

 $\dagger I = input, O = output$

NOTE 1: Pin has an internal pullup device to maintain a high-voltage level when left unconnected (no etch).



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Pin Functions (Continued)

DIN	Pin Functions (Continued)					
PIN NAME	NO.	ı/o†	DESCRIPTION			
SHLDA/SBGR	58	I	Intel Mode	 SHLDA is used for system-hold acknowledge. SHLDA indicates that the system DMA hold request has been acknowledged. It is internally synchronized to SBCLK (see Note 1). H = Hold request acknowledged L = Hold request not acknowledged 		
			Motorola Mode	SBGR is used for system bus grant. SBGR is an active-low bus grant, as defined in the standard 68xxx interface, and is internally synchronized to SBCLK (see Note 1). H = System bus not granted L = System bus granted		
SHRQ/SBRQ	78	0	Intel Mode	 SHRQ is used for system-hold request. SHRQ is used to request control of the system bus in preparation for a DMA transfer. SHRQ is internally synchronized to SBCLK. H = System bus requested L = System bus not requested 		
SHKU/ SBKU	70	0	Motorola Mode	 SBRQ is used for system-bus request. SBRQ is used to request control of the system bus in preparation for a DMA transfer. SBRQ is internally synchronized to SBCLK. H = System bus not requested L = System bus requested 		
SIACK	43	I	System-interrupt acknowledge. SIACK is from the host processor to acknowledge the interrupt request from the TI380C25. H = System interrupt not acknowledged (see Note 1) L = System interrupt acknowledged: The TI380C25 places its interrupt vector onto the system bus.			
sı/M	56	I	 System Intel/Motorola mode select. The value on SI/M specifies the system-interface mode. H = Intel-compatible interface mode selected. Intel interface can be 8-bit or 16-bit mode (see S8/SHALT description and Note 1). L = Motorola-compatible interface mode selected. Motorola interface mode is always 16 bits. 			
SINTR/SIRQ	57	0	Intel Mode	SINTR is used for system-interrupt request. TI380C25 activates SINTR to signal an interrupt request to the host processor. H = Interrupt request by TI380C25 L = No interrupt request		
SINTR/SIRQ	57	0	Motorola Mode	SIRQ is used for system-interrupt request. TI380C25 activates SIRQ to signal an interrupt request to the host processor. H = No interrupt request L = Interrupt request by TI380C25		
SOWN	81	0	SOWN drive signals. H = TI380	wowned. SOWN indicates to external devices that TI380C25 has control of the system bus. s the enable signal of the bus-transceiver chips that drive the address and bus-control C25 does not have control of the system bus. C25 has control of the system bus.		

 $\dagger I = input, O = output$

NOTE 1: Pin has an internal pullup device to maintain a high-voltage level when left unconnected (no etch).



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Pin Functions (Continued)

PIN					
NAME	NO.	1/0†	DESCRIPTION		
SPH	84	I/O	System parity high. The optional odd-parity bit for each address or data byte transmitted over SADH0-SADH7 (see Note 1).		
SPL	77	I/O		ty low. The optional odd-parity bit for each address or data byte transmitted over DL7 (see Note 1).	
SRAS/SAS	60	I/O	Intel Mode	SRAS is used for system memory-address strobe (see Note 7). SRAS is used to latch the SCS and SRSX – SRS2 register input signals. In a minimum-chip system, SRAS is tied to the SALE output of the system bus. The latching capability can be defeated because the internal latch for these inputs remains transparent as long as SRAS remains high. This permits SRAS to be pulled high and the signals at SCS, SRSX – SRS2, and SBHE to be applied independently of the SALE strobe from the system bus. During DMA, SRAS remains an input. H = Transparent mode L = Holds latched values of SCS, SRSX–SRS2, and SBHE Falling edge = Latches SCS, SRSX – SRS2, and SBHE	
			Motorola Mode	SAS is used for sytem-memory address strobe (see Note 7). SAS is an active-low address strobe that is an input during DIO (although ignored as an address strobe) and an output during DMA. H = Address is not valid. L = Address is valid and a transfer operation is in progress.	
SRD/SUDS	83	1/0	Intel Mode	SRD is used for system-read strobe (see Note 7). SRD is the active-low strobe indicating that a read cycle is performed on the system bus. SRD is an input during DIO and an output during DMA. H = Read cycle is not occurring. L = If DMA, host provides data to system bus. If DIO, SIF provides data to system bus.	
				Motorola Mode	SUDS is used for upper-data strobe (see Note 7).SUDS is the active-low upper-datastrobe.SUDS is an input during DIO and an output during DMA.H = Not valid data on SADH0-SADH7 linesL = Valid data on SADH0-SADH7 lines
	82		Intel Mode	SRDY is used for system bus ready (see Note 7). SRDY indicates to the bus master that a data transfer is complete. SRDY is asynchronous but during DMA and pseudo-DMA cycles, it is internally synchronized to SBCLK. During DMA cycles, SRDY must be asserted before the falling edge of SBCLK in state T2 to prevent a wait state. SRDY is an output when the TI380C25 is selected for DIO; otherwise; it is an input.H=System bus is not ready.L=Data transfer is complete; system bus is ready.	
SRDY/SDTACK		1/0	Motorola Mode	<u>SDTACK</u> is used for system data-transfer acknowledge (see Note 7). The <u>purpose</u> of <u>SDTACK</u> is to indicate to the bus master that a data transfer is complete. <u>SDTACK</u> is internally synchronized to SBCLK. During DMA cycles, <u>SDTACK</u> must be <u>asserted</u> before the falling edge of SBCLK in state T2 in order to prevent a wait state. <u>SDTACK</u> is an output when the TI380C25 is selected for DIO; otherwise, it is an input.	
				 H = System bus is not ready. L = Data transfer is complete; system bus is ready. 	

 \dagger I = input, O = output

NOTES: 1. Pin has an internal pullup device to maintain a high-voltage level when left unconnected (no etch).

7. Pin should be tied to V_{CC} with a 4.7-k Ω pullup resistor.



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Pin Functions (Continued)

PIN			l I			
NAME	NO.	ı/o†		DESCRIPTION		
SRESET	44	I	System reset. SRESET is activated to place the TI380C25 into a known initial state. Hardware reset puts most of the TI380C25 outputs into the high-impedance state and places all blocks into the reset state. The Intel mode DMA bus-width selection (S8) is latched on the rising edge of SRESET. H = No system reset L = System reset Rising edge = Latch bus width for DMA operations (for Intel-mode applications)			
			Intel Mode	SRSX and SRS0-SRS2 are used for system-register select. These inputs select the word or byte to be transferred during a system DIO access. The most significant bit is SRSX and the least significant bit is SRS2 (see Note 1). MSb LSb Register selected = SRSX SRS0 SRS1 SRS2/SBERR		
SRSX SRS0 SRS1 SRS2/SBERR	47 46 45 54	I	Motorola Mode	SRSX, SRS0 and SRS1 are used for system-register select. These inputs select the word or byte to be transferred during a system DIO access. The most significant bit is SRSX and the least significant bit is SRS1 (see Note 1). MSb LSb Register selected = SRSX SRS0 SBERR is used for bus error. This signal corresponds to the bus-error signal of the 68xxx microprocessor. SBERR is internally synchronized to SBCLK. This input is driven low during a DMA cycle to indicate to the TI380C25 that the cycle must be terminated (see Section 3.4.5.3 of the TMS380 Second-Generation Token Ring User's Guide (SPWU005) for more information).		
SWR/SLDS	61	1/0	Intel Mode Motorola Mode	 SWR is used for system-write strobe (see Note 7). SWR is an active-low write strobe that is an input during DIO and an output during DMA. H = Write cycle is not occurring. L = If DMA, data to be driven from SIF to host bus. If DIO, on the rising edge, the data is latched and written to the selected register. SLDS is used for lower-data strobe (see Note 7). SLDS is an input during DIO and an output during DMA. H = Not valid data on SADL0-SADL7 lines L = Valid data on SADL0-SADL7 lines 		
SXAL	63	0	System-extended-address latch. SXAL provides the enable pulse used to externally latch the most significant 16 bits of the 32-bit system address during DMA. SXAL is activated prior to the first cycle of each block DMA transfer, and thereafter as necessary (whenever an increment of the DMA address counter causes a carry out of the lower 16 bits). Systems that implement parity on addresses can use SXAL to externally latch the parity bits (available on SPL and SPH) for the DMA address extension.			
			SXAL to exte	ernally latch the parity bits (available on SPL and SPH) for the DMA address extension.		

 $\dagger I = input, O = output$

NOTES: 1: Pin has an internal pullup device to maintain a high-voltage level when left unconnected (no etch).
7. Pin should be tied to V_{CC} with a 4.7-kΩ pullup resistor.



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Pin Functions (Continued)						
PIN NAME	NO.	1/0 †	DESCRIPTION			
S8/ SHALT	51	I	S8 is used for system 8/16-bit bus select. S8 selects the bus width used for communications through the system interface. On the rising edge of SRESET, the TI380C25 latches the DMA bus width; otherwise, the value on S8 dynamically selects the DIO bus width.Intel ModeH = Selects 8-bit mode (see Note 1) 			
			Motorola Mode SHALT is used for system halt/bus error retry. If SHALT is asserted along with SBERR, the adapter retries the last DMA cycle. This is the rerun operation as defined in the 68xxx specification. The BERETRY counter is not decremented by SBERR when SHALT is asserted (see Section 3.4.5.3 of the <i>TMS380 Second-Generation Token Ring User's</i> <i>Guide</i> (SPWU005) for more information).			
VDDL	37 55 126	I	Positive-supply voltage for digital logic. All $V_{\mbox{DDL}}$ pins must be attached to the common-system power-supply plane.			
VDD	9 34 72 89 106 137	I	Positive-supply voltage for output buffers. All $V_{\mbox{DD}}$ pins must be attached to the common-system power-supply plane.			
VSSC	39 87 117 144	I	Ground reference for output buffers (clean ground). All V _{SSC} pins must be attached to the common-system ground plane.			
VSSL	2 52 53 73 36 108 128 129	I	Ground reference for digital logic. All V_{SSL} pins must be attached to the common-system ground plane.			
V _{SS}	11 19 62 91 134	I	Ground connections for output buffers. All $V_{\mbox{SS}}$ pins must be attached to system ground plane.			
	1 10 35 71 88 90 107 109		These pins should be left unconnected.			

 $\dagger I = input, O = output$

NOTE 1: Pin has an internal pullup device to maintain a high-voltage level when left unconnected (no etch).



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Pin Functions (Continued)

Token-Ring Media Interface

PIN		ı/o†			
NAME	NAME NO.		DESCRIPTION		
DRVR DRVR	115 114	0	Differential-driver data output. DRVR and DRVR are the differential outputs that send the TI380C25 transmit data to the TMS38054 for driving onto the ring-transmit-signal pair.		
FRAQ	111	0	 Frequency-acquisition control. FRAQ determines the use of frequency- or phase-acquisition mode in the TMS38054. H = Wide range. Frequency centering to PXTALIN by TMS38054. L = Narrow range. Phase lock onto the incoming data (RCVINA and RCVINB) by the TMS38054. 		
NSRT	112	0	Insert-control signal to the TMS38054. NSRT enables the phantom-driver outputs (PHOUTA and PHOUTB) of the TMS38054, through the watchdog timer, for insertion onto the token ring. Static high = Inactive, phantom current removed (due to watchdog timer) Static low = Inactive, phantom current removed (due to watchdog timer) NSRT low and pulsed high = Active, current output on PHOUTA and PHOUTB		
PXTALIN	118	I	Ring-interface clock-frequency control (see Note 5). At 16-Mbps ring speed, PXTALIN must be supplied a 32-MHz signal. At 4-Mbps ring speed, PXTALIN must be 8 MHz and can be the output from OSCOUT.		
RCLK	120	I	Ring-interface recovered clock (see Note 5). RCLK is the clock recovered by the TMS38054 from the token-ring received data. For 16-Mbps operation, RCLK is a 32-MHz clock; for 4-Mbps operation, RCLK is an 8-MHz clock.		
RCVR	121	I	Ring-interface received data (see Note 5). RCVR contains the data received by the TMS38054 from the token ring.		
REDY	110	I	Ring-interface ready. REDY indicates the presence of received data as monitored by the TMS38054 energy-detect capacitor. H = Not ready. Ignore received data. L = Ready. Received data.		
WFLT	113	I	Wire-fault detect. WFLT is an input to the TI380C25 driven by the TMS38054. WFLT indicates a current imbalance of the TMS38054 PHOUTA and PHOUTB pins. H = No wire fault detected L = Wire fault detected		
WRAP	116	0	L = Wire fault detected Internal wrap select. WRAP is an output from the TI380C25 to the ring interface to activate an intattenuated feedback path from the transmitted data (DRVR) to receive data (RCVR) signal bring-up diagnostic testing. When active, the TMS38054 also cuts off the current drive to transmission pair. H = Normal ring operation L = Transmit data drives receive data (loopback).		

† I = input, O = output NOTE 5: Pin has an expanded input-voltage specification.



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Pin Functions (Continued)

Token-Ring Media Interface

PIN	PIN		DESCRIPTION			
NAME	NO.	ı/o†	DESCRIPTION			
TEST0 TEST1 TEST2	103 102 101	I	Network select inputs. TEST0 – TEST2 are used to select the network speed and type to be used by the TI380C25. These inputs should be changed only during adapter reset. Connect TEST2 to V _{DDL} . TEST0 TEST1 TEST2 DESCRIPTION L NC H 16-Mbps token ring H NC H 4-Mbps token ring X X L Reserved			
TEST3 TEST4 TEST5	100 99 98	I	Test inputs. TEST3–TEST5 should be left unconnected (see Note 1). Module-in-place test mode is achieved by tying TEST3 and TEST4 to ground. In this mode, all TI380C25 outputs are in the high-impedance state. Internal pullups on all TI380C25 inputs are disabled (except TEST3–TEST5).			
XFAIL	104	I	External fail-to-match signal. An enhanced-address-copy-option (EACO) device uses XFAIL to indicate to the TI380C25 that it should not copy the frame nor set the ARI/FCI bits in a token-ring frame due to an external address match. The ARI/FCI bits in a token-ring frame can be set due to an internal address-matched frame. If an EACO device is not used, XFAIL must be left unconnected. XFAIL is ignored when CAF mode is enabled [see table in XMATCH description (see Note 1)]. H = No address match by external address checker L = External address-checker-armed state			
ХМАТСН	105	I	L = External address-checker-armed state External match signal. An enhanced-address-copy-option (EACO) device uses XMATCH to indicate to the TI380C25 to copy the frame and set the ARI/FCI bits in a token-ring frame. If an EACO device is not used, XMATCH must be left unconnected. XMATCH is ignored when CAF mode is enabled (see Note 1). H = Address match recognized by external address checker L = External address-checker-armed state XMATCH XFAIL FUNCTION 0 0 Armed (processing frame data) 0 1 Do not externally match the frame (XFAIL takes precedence). 1 0 Copy the frame 1 1 Do not externally match the frame (XFAIL takes precedence). Hi-Z Hi-Z Reset state (adapter not initialized)			

 \dagger I = input, O = output

NOTE 1: Pin has an internal pullup device to maintain a high-voltage level when left unconnected (no etch).



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architecture

The major blocks of the TI380C25 include the communications processor (CP), system interface (SIF), memory interface (MIF), protocol handler (PH), clock generator (CG), and adapter-support function (ASF). The functionality of each block is described in the following sections.

communications processor (CP)

The CP performs the control and monitoring of the other functional blocks in the TI380C25. The control and monitoring protocols are specified by the software (downloaded or ROM based) in local memory. Available protocols include:

- Media access control (MAC) software
- Logical link control (LLC) software
- Copy all frames (CAF) software

The CP is a proprietary 16-bit central processing unit (CPU) with data cache and a single prefetch pipe for pipelining of instructions. These features enhance the TI380C25 maximum performance capability to about 8 million instructions per second (MIPS) with an average of about 5 MIPS.

system interface (SIF)

The SIF performs the interfacing of the LAN subsystem to the host system. This interface may require additional logic depending on the application. The system interface can transfer information/data using any of these three methods:

- Direct memory access (DMA)
- Direct input/output (DIO)
- Pseudo-direct memory access (PDMA)

DMA (or PDMA) is used to transfer all data to/from host memory from / to local memory. The main uses of DIO are for loading the software to local memory and for initializing the TI380C25. DIO also allows command/status interrupts to occur to and from the TI380C25.

The system interface can be hardware selected for either of two modes by use of SI / \overline{M} . The mode selected determines the memory organizations and control signals used. These modes are as follows:

- The Intel 80x8x families: 8-, 16-, and 32-bit bus devices
- The Motorola 68xxx microprocessor family: 16- and 32-bit bus devices

The system interface supports host-system memory addressing up to 32 bits (32-bit reach into the host-system memory). This allows greater flexibility in using/accessing host-system memory. System designers can customize the system interface to their particular bus by using one of the following:

- Programmable burst transfers or cycle-steal DMA operations
- Optional parity protection

These features are implemented in hardware to reduce system overhead, facilitate automatic rearbitration of the bus after a burst, or repeat a cycle when errors occur (parity or bus). Bus retries are also supported.

The system-interface hardware also includes features to enhance the integrity of the TI380C25 and the data. These features include the following:

- Always internally maintain odd-byte parity regardless of parity being disabled
- Monitor for the presence of a clock failure
- Can switch SIF speeds from 2 MHz to 33 MHz

On every cycle, the system interface compares all the system clocks to a reference clock. If any of the clocks become invalid, the TI380C25 enters the slow-clock mode, which prevents latch-up of the TI380C25. If the SBCLK is invalid, any DMA cycle is terminated immediately; otherwise, the DMA cycle is completed and the TI380C25 is placed in slow-clock mode.



system interface (SIF) (continued)

When the TI380C25 enters the slow-clock mode, the clock that failed is replaced by a slow free-running clock and the device is placed into a low-power reset state. When the failed clock(s) return to valid operation, the TI380C25 must be reinitialized.

For DMA with a 16-MHz clock, a continuous transfer rate of 64 megabits per second (8 Mbps) can be obtained. For DMA with a 25-MHz clock, a continuous transfer rate of 96 megabits per second (12 Mbps) can be obtained. For DMA with a 33-MHz clock, a continuous transfer rate of 128 megabits per second (16 Mbps) can be obtained. For 8-bit and 16-bit pseudo-DMA, the following data rates can be obtained:

LOCAL BUS SPEED	8-BIT PDMA	16-BIT PDMA
4 MHz	48 Mbps	64 Mbps
6 MHz	72 Mbps	96 Mbps

Since the main purpose of DIO is for downloading and initialization, the DIO transfer rate is not a significant issue.

memory interface (MIF)

The MIF performs the memory management to allow the TI380C25 to address 2M bytes in local memory. Hardware in the MIF allows the TI380C25 to be directly connected to DRAMs without additional circuitry. This glueless-DRAM connection includes the DRAM refresh controller. The MIF also handles all internal bus arbitration between these blocks. When required, the MIF then arbitrates for the external bus.

The MIF is responsible for the memory mapping of the CPU of a task. The memory maps of DRAMs, EPROMs, burned-in addresses (BIA), and external devices are appropriately addressed when required by the system interface, protocol handler, or for a DMA transfer.

The memory interface is capable of a 64-Mbps continuous transfer rate when using a 4-MHz local bus (64-MHz device crystal) and a 96-Mbps continuous transfer rate when using a 6-MHz local bus.

protocol handler (PH)

The PH performs the hardware-based real-time protocol functions for a token-ring LAN. Network type is determined by TEST0–TEST2. Token-ring network is determined by software and can be either 16 Mbps or 4 Mbps. These speeds are not fixed by the hardware but by the software.

The PH converts the parallel-transmit data to serial-network data of the appropriate coding and converts the received serial data to parallel data. The PH data-management state machines direct the transmission / reception of data to / from local memory through the MIF. The PH buffer-management state machines automatically oversee this process, directly sending / receiving linked lists of frames without CPU intervention.

The protocol handler contains many state machines that provide the following features:

- Transmit and receive frames
- Capture tokens
- Provide token-priority controls
- Manage the TI380C25 buffer memory
- Provide frame-address recognition (group, specific, functional, and multicast)
- Provide internal parity protection
- Control and verify the PHY-layer circuitry-interface signals

Integrity of the transmitted and received data is assured by cyclic redundancy checks (CRC), detection of network data violations, and parity on internal data paths. All data paths and registers are optionally parity protected to assure functional integrity.



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adapter-support function (ASF)

The ASF performs support functions not contained in the other blocks. The support functions are:

- The TI380C25 base timer
- Identification, management, and service of internal and external interrupts
- Test-pin mode control, including the unit-in-place mode for board testing
- Illegal state check (checks for illegal states such as parity and illegal opcodes)

clock generator (CG)

The CG performs the generation of all the internal clocks required by the other functional blocks, including the local memory-bus clocks (MBCLK1, MBCLK2). The CG also generates the reference timer used to sample all input clocks (SBCLK, OSCIN, RCLK, and PXTALIN). If no transition is detected within the period of the reference timer on any input clock signal, the CG places the TI380C25 into slow-clock mode. The frequency of the reference timer is in the range of 10 kHz–100 kHz.

user-accessible hardware registers and TI380C25 internal pointers

The following tables show how to access internal data via pointers and how to address the registers in the host interface. The SIFACL register, which directly controls device operation, is described in detail. The adapter-internal pointers table on the following page is defined only after TI380C25 initialization and until the OPEN command is issued. These pointers are defined by the TI380C25 software (microcode), and this table describes the release 2.x of the TI380C25 software.



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ADDRESS	DESCRIPTION
>00.FFF8 [‡]	Pointer to software raw microcode level in chapter 0
>00.FFFA [‡]	Pointer to starting location of copyright notices. Copyright notices are separated by a $>0A$ character and terminated by a >00 character in chapter 0.
>01.0A00	Pointer to burned-in address in chapter 1
>01.0A02	Pointer to software level in chapter 1
>01.0A04	Pointer to TI380C25 addresses in chapter 1: Pointer + 0 node address Pointer + 6 group address Pointer + 10 functional address
>01.0A06	Pointer to TI380C25 parameters in chapter 1: Pointer + 0 physical-drop number Pointer + 4 upstream neighbor address Pointer + 10 upstream physical-drop number Pointer + 14 last ring-poll address Pointer + 20 reserved Pointer + 22 transmit access priority Pointer + 24 source class authorization Pointer + 26 last attention code Pointer + 26 last attention code Pointer + 28 source address of the last received frame Pointer + 34 last beacon type Pointer + 34 last beacon type Pointer + 38 ring status Pointer + 40 soft-error timer value Pointer + 40 soft-error timer value Pointer + 44 local ring number Pointer + 44 local ring number Pointer + 48 last beacon-transmit type Pointer + 50 last beacon-receive type Pointer + 52 last MAC-frame correlator Pointer + 54 last beaconing-station physical-drop number
>01.0A08	Pointer to MAC buffer (a special buffer used by the software to transmit adapter-generated MAC frames) in chapter 1
>01.0A0A	Pointer to LLC counters in chapter 1: Pointer + 0 MAX_SAPs Pointer + 1 open SAPs Pointer + 2 MAX_STATIONs Pointer + 3 open stations Pointer + 4 available stations Pointer + 5 reserved
>01.0A0C	Pointer to 4-/16-Mbps word flag. If zero, the adapter is set to run at 4 Mbps. If nonzero, the adapter is set to run at 16 Mbps.
>01.0A0E	Pointer to total TI380C25 RAM found in 1K bytes in RAM allocation test in chapter 1.

Adapter-Internal Pointers for Token Ring[†]

[†] This table describes the pointers for release 2.x of the TI380C25 software.

 \ddagger This address valid only for microcode release 2.x



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User-Access Hardware Registers

WORD TRANSFERS			SBH	AL MODE 1E = 0 S2 = 0	PSEUDO-DMA MODE ACTIVE SBHE = 0 SRS2 = 0		
			SBHE = 0 SRS2 = 1	SBHE = 1 SRS2 = 0	SBHE = 0 SRS2 = 1	SBHE = 1 SRS2 = 0	
SRSX	SRS0	SRS1					
0	0	0	SIFDAT MSB	SIFDAT LSB	SDMADAT MSB	SDMADAT LSB	
0	0	1	SIFDAT / INC MSB	SIFDAT / INC LSB	DMALEN MSB	DMALEN LSB	
0	1	0	SIFADR MSB	SIFADR LSB	SDMAADR MSB	SDMAADR LSB	
0	1	1	SIFCMD	SIFSTS	SDMAADX MSB	SDMAADX LSB	
1	0	0	SIFACL MSB	SIFACL LSB	SIFACL MSB	SIFACL LSB	
1	0	1	SIFADR MSB	SIFADR LSB	SIFADR MSB	SIFADR LSB	
1	1	0	SIFADX MSB	SIFADX LSB	SIFADX MSB	SIFADX LSB	
1	1	1	DMALEN MSB	DMALEN LSB	DMALEN MSB	DMALEN LSB	

[†]SBHE = 1 and SRS2 = 1 are not defined

80x8x 8-BIT MODE: (SI / \overline{M} = 1, S8/SHALT = 1)

SRSX	SRS0	SRS1	SRS2	NORMAL MODE SBHE = X	PSEUDO- <u>DMA M</u> ODE ACTIVE SBHE = X
0	0	0	0	SIFDAT LSB	SDMADAT LSB
0	0	0	1	SIFDAT MSB	SDMADAT MSB
0	0	1	0	SIFDAT/INC LSB	DMALEN LSB
0	0	1	1	SIFDAT/INC MSB	DMALEN MSB
0	1	0	0	SIFADR LSB	SDMAADR LSB
0	1	0	1	SIFADR MSB	SDMAADR MSB
0	1	1	0	SIFSTS	SDMAADX LSB
0	1	1	1	SIFCMD	SDMAADX MSB
1	0	0	0	SIFACL LSB	SIFACL LSB
1	0	0	1	SIFACL MSB	SIFACL MSB
1	0	1	0	SIFADR LSB	SIFADR LSB
1	0	1	1	SIFADR MSB	SIFADR MSB
1	1	0	0	SIFADX LSB	SIFADX LSB
1	1	0	1	SIFADX MSB	SIFADX MSB
1	1	1	0	DMALEN LSB	DMALEN LSB
1	1	1	1	DMALEN MSB	DMALEN MSB

l

68xxx MC	68xxx MODE: (SI/M = 0) [‡]								
WORD TRANSFERS			NORMAL MODE SUDS = 0 SLDS = 0		PSEUDO-DMA MODE ACTIVE SUDS = 0 SLDS = 0				
BYTE TRANSFERS			SUDS = 0 SLDS = 1	SUDS = 1 SLDS = 0	SUDS = 0 SLDS = 1	SUDS = 1 SLDS = 0			
SRSX	SRS0	SRS1							
0	0	0	SIFDAT MSB	SIFDAT LSB	SDMADAT MSB	SDMADAT LSB			
0	0	1	SIFDAT/INC MSB	SIFDAT/INC LSB	DMALEN MSB	DMALEN LSB			
0	1	0	SIFADR MSB	SIFADR LSB	SDMAADR MSB	SDMAADR LSB			
0	1	1	SIFCMD	SIFSTS	SDMAADX MSB	SDMAADX LSB			
1	0	0	SIFACL MSB	SIFACL LSB	SIFACL MSB	SIFACL LSB			
1	0	1	SIFADR MSB	SIFADR LSB	SIFADR MSB	SIFADR LSB			
1	1	0	SIFADX MSB	SIFADX LSB	SIFADX MSB	SIFADX LSB			
1	1	1	DMALEN MSB	DMALEN LSB	DMALEN MSB	DMALEN LSB			

[‡]68xxx mode is always 16 bit.

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SIF adapter-control register (SIFACL)

The SIFACL register allows the host processor to control and to some extent reconfigure the TI380C25 under software control.



SIFACL Register

Legend:

- R = Read
- W = Write
- P = Write during ARESET = 1 only
- S = Set only
- -n = Value after reset
- b = Value on BTSTRP
- p = Value on PRTYEN
- u = Indeterminate

Bits 0–2: Value on TEST0 and TEST2 pins

These bits are read only and always reflect the value on the corresponding device pins. This allows the host S/W to determine speed configuration. If the network speed and type are software configurable, these bits can be used to determine which configurations are supported by the network hardware.

TEST0	TEST1	TEST2	Description
L	NC	н	16-Mbps token ring
Н	NC	Н	4-Mbps token ring
Х	Х	L	Reserved

Bit 3: Reserved. Read data is indeterminate.

Bit 4: SWHLDA — Software Hold Acknowledge

This bit allows the function of SHLDA/SBGR to be emulated from software control for pseudo-DMA mode.

PSDMAEN	SWHLDA	SWHRQ	RESULT
0†	Х	Х	SWHLDA value in the SIFACL register cannot be set to a one.
1†	0	0	No pseudo-DMA request pending
1†	0	1	Indicates a pseudo-DMA request interrupt
1†	1	Х	Pseudo-DMA process in progress

[†] The value on SHLDA / SBGR is ignored.



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Bit 5: SWDDIR — Current SDDIR Signal Value

This bit contains the current value of the pseudo-DMA direction. This enables the host to easily determine the direction of DMA transfers, which allows system DMA to be controlled by system software.

- 0 = Pseudo DMA from host system to TI380C25
- 1 = Pseudo DMA from TI380C25 to host system

Bit 6: SWHRQ — Current SHRQ Signal Value

This bit contains the current value on SHRQ/SBRQ when in Intel mode, and the inverse of the value on SHRQ/SBRQ when in Motorola mode. This enables the host to easily determine if a pseudo-DMA transfer is requested.

INTEL MODE (SI/ \overline{M} = H)

0 = System bus not requested

1 = System bus requested

MOTOROLA MODE $(SI/\overline{M} = L)$ System bus not requested System bus requested

Bit 7: PSDMAEN — Pseudo-System-DMA Enable

This bit enables pseudo-DMA operation.

- 0 = Normal bus-master DMA operation is possible.
- 1 = Pseudo-DMA operation selected. Operation dependent on the values of the SWHLDA and SWHRQ bits in the SIFACL register.

Bit 8: ARESET — Adapter Reset

This bit is a hardware reset of the TI380C25. This bit has the same effect as SRESET except that the DIO interface to the SIFACL register is maintained. This bit is set to 1 if a clock failure is detected (OSCIN, PXTALIN, RCLK, or SBCLK not valid).

- 0 = The TI380C25 operates normally.
- 1 = The TI380C25 is held in the reset condition.

Bit 9: CPHALT — Communications-Processor Halt

This bit controls the TI380C25 processor access to the internal TI380C25 buses. This prevents the TI380C25 from executing instructions before the microcode has been downloaded.

- 0 = The TI380C25 processor can access the internal TI380C25 buses.
- 1 = The TI380C25 processor is prevented from accessing the internal adapter buses.

Bit 10: BOOT — Bootstrap CP Code

This bit indicates whether the memory in chapters 0 and 31 of the local-memory space is RAM or ROM/PROM/EPROM. This bit controls the operation of MCAS and MROMEN.

- 0 = ROM/PROM/EPROM memory in chapters 0 and 31
- 1 = RAM memory in chapters 0 and 31



Bit 11: LBP — Local-Bus Priority

1

This bit controls the priority levels of devices on the local bus.

- 0 = No external devices (such as TI380FPA) are used with the TI380C25.
 - = An external device (such as TI380FPA) is used with the TI380C25. This allows the external bus master to operate at the necessary priorities on the local bus.

If the system uses the TMS380SRA only, the bit must be set to 0. If the system uses both the TMS380SRA and the TI380FPA, the bit must be set to 1.

Bit 12: SINTEN — System-Interrupt Enable

This bit allows the host processor to enable or disable system-interrupt requests from the TI380C25. The system-interrupt request from the TI380C25 is on SINTR/SIRQ. The following equation shows how SINTR/SIRQ is driven. The table also explains the results of the states.

SINTR/SIRQ = (PSDMAEN * S	WHRQ * ISWHLDA) + (SINTEN	* SYSTEM_INTERRUPT)
---------------------------	---------------------------	---------------------

PSDMAEN	SWHRQ	SWHLDA	SINTEN	SYSTEM INTERRUPT (SIFSTS REGISTER)	RESULT
1†	1	1	Х	Х	Pseudo DMA is active.
1†	1	0	Х	Х	The TI380C25 generated a system interrupt for a pseudo DMA.
1†	0	0	Х	Х	Not a pseudo-DMA interrupt
Х	Х	Х	1	1	The TI380C25 generates a system interrupt.
0	Х	Х	1	0	The TI380C25 does not generate a system interrupt.
0	Х	Х	0	Х	The TI380C25 cannot generate a system interrupt.

[†] The value on SHLDA / SBGR is ignored.

Bit 13: PEN — Parity Enable

This bit determines whether data transfers within the TI380C25 are checked for parity.

- 0 = Data transfers are not checked for parity.
- 1 = Data transfers are checked for correct odd parity.

Bit 14 – 15: NSELOUT0, NSELOUT0 1 — Network-Selection Outputs

The values in these bits control NSELOUT0 and NSELOUT1. These bits can be modified only while the ARESET bit is set.

These bits can be used to software configure a TI380C25 as follows: NSELOUT0 should be connected to TEST0 (TEST1 should be left unconnected and TEST2 should be tied high). NSELOUT0 and NSELOUT1 are used to select network speed as shown below:

NSELOUT0	NSELOUT1	SELECTION
0	0	Reserved
0	1	16-Mbps token ring
1	0	Reserved
1	1	4-Mbps token ring

At power up, these bits are set corresponding to 16-Mbps token ring (NSELOUT1 = 1, NSELOUT0 = 0).



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SIFACL control for pseudo-DMA operation

Pseudo DMA is software controlled by the use of five bits in the SIFACL register. The logic model for the SIFACL register control of pseudo-DMA operation is shown in Figure 2.



Figure 2. Pseudo-DMA Logic Related to SIFACL Bits



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Supply voltage, V _{DD} (see Note 8)	7 V
Input voltage range, V _I (see Note 8)	. $-$ 0.3 V to 20 V
Output voltage range	\ldots – 2 V to 7 V
Power dissipation	0.9 W
Operating free-air temperature range, T _A	0°C to 70°C
Storage temperature range	-65°C to 150°C

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
 NOTE 8: Voltage values are with respect to VSS.

recommended operating conditions

		MIN	NOM	MAX	UNIT
Supply voltage		4.75	5	5.25	V
Supply voltage (see Note 9)		0	0	0	V
High-level input voltage	TTL-level signal	2		V _{DD} +0.3	V
	OSCIN	2.4		V _{DD} +0.3	
	RCLK, PXTALIN, RCVR	2.6		V _{DD} +0.3	
Low-level input voltage, TTL-level signal (see Note 10)		-0.3		0.8	V
High-level output current				-400	μΑ
High-level output current (see Note 11)				2	mA
Operating free-air temperature		0		70	°C
Operating case temperature				100	°C
	Supply voltage (see Note 9) High-level input voltage Low-level input voltage, TTL-level signal (see Note 10) High-level output current High-level output current (see Note 11) Operating free-air temperature	Supply voltage (see Note 9) TTL-level signal High-level input voltage OSCIN RCLK, PXTALIN, RCVR Low-level input voltage, TTL-level signal (see Note 10) High-level output current High-level output current (see Note 11) Operating free-air temperature	Supply voltage 4.75 Supply voltage (see Note 9) 0 High-level input voltage 12 OSCIN 2.4 RCLK, PXTALIN, RCVR 2.6 Low-level input voltage, TTL-level signal (see Note 10) -0.3 High-level output current -0.3 High-level output current (see Note 11) 0 Operating free-air temperature 0	Supply voltage 4.75 5 Supply voltage (see Note 9) 0 0 High-level input voltage 2 2 Note Name Note Name 2 RCLK, PXTALIN, RCVR 2.6 2 Low-level input voltage, TTL-level signal (see Note 10) -0.3 -0.3 High-level output current -0.3 -0.3 High-level output current (see Note 11) 0 0	Supply voltage4.7555.25Supply voltage (see Note 9)000High-level input voltageTTL-level signal2VDD+0.3OSCIN2.4VDD+0.3RCLK, PXTALIN, RCVR2.6VDD+0.3Low-level input voltage, TTL-level signal (see Note 10)-0.30.8High-level output current-0.30.8High-level output current (see Note 11)22Operating free-air temperature070

NOTES: 9. All V_{SS} pins should be routed to minimize inductance to system ground.

10. The algebraic convention, where the more negative (less positive) limit is designated as a minimum, is used for logic-voltage levels only.

11. Output current of 2 mA is sufficient to drive five low-power Schottky TTL loads or ten advanced low-power Schottky TTL loads (worst case).

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

	PARAMETER	TEST CONDITIONS [‡]	MIN	TYP	MAX	UNIT
VOH	High-level output voltage, TTL-level signal (see Note 12)	V _{DD} = MIN, I _{OH} = MAX	2.4			V
VOL	Low-level output voltage, TTL-level signal	$V_{DD} = MIN, \qquad I_{OL} = MAX$			0.6	V
	High impedance output ourrent	$V_{DD} = MAX, V_O = 2.4 V$			20	
10	High-impedance output current	$V_{DD} = MAX, V_{O} = 0.4 V$			- 20	μA
Ц	Input current, any input or input / output	$V_I = V_{SS}$ to V_{DD}			±20	μΑ
IDD	Supply current	V _{DD} = MAX			160	mA
ISCM	Supply current, slow-clock mode	$V_{DD} = 5 V$		3		mA
Ci	Input capacitance, any input	f = 1 MHz, Others at 0 V			15	pF
Co	Output capacitance, any output or input/output	f = 1 MHz, Others at 0 V			15	pF

[‡]For conditions shown as MIN/MAX, use the appropriate value specified under the recommended operating conditions.

NOTE 12: The following signals require an external pullup resistor: SRAS/SAS, SRDY/SDTACK, SRD/SUDS, SWR/SLDS, EXTINT0-EXTINT3, and MBRQ.



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PARAMETER MEASUREMENT INFORMATION

timing parameters

The timing parameters for all the signals of the TI380C25 are shown in the following tables and are illustrated in the accompanying figures. The purpose of these figures and tables is to quantify the timing relationships among the various signals. The parameters are numbered for convenience.

static signals

The following table lists signals that are not allowed to change dynamically and therefore have no timing associated with them. They should be strapped high, low, or left unconnected as required.

SIGNAL	FUNCTION
SI/M	Host-processor select (Intel/Motorola)
CLKDIV	Reserved
BTSTRP	Default-bootstrap mode (RAM/ROM)
PRTYEN	Default-parity select (enabled/disabled)
TEST0	Test terminal indicates network type
TEST1	NC
TEST2	Test terminal indicates network type
TEST3	Test terminal for TI manufacturing test [†]
TEST4	Test terminal for TI manufacturing test [†]
TEST5	Test terminal for TI manufacturing test [†]

† For unit-in-place test

timing parameter symbology

Some timing parameter symbols have been created in accordance with JEDEC Standard 100-A. In order to shorten the symbols, some of the signal names and other related terminology have been abbreviated as shown below:

D	R	DRVR	RS	SRESET
D	RN	DRVR	VDD	$v_{\text{DDL}}, v_{\text{DD}}$
0	SC	OSCIN		
S	СК	SBCLK		

Lower case subscripts are defined as follows:

С	cycle time	r	rise time
d	delay time	sk	skew
h	hold time	su	setup time
W	pulse duration (width)	t	transition time

The following additional letters and phrases are defined as follows:

н	High	Z	High impedance
L	Low	Falling edge	No longer high
V	Valid	Rising edge	No longer low



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PARAMETER MEASUREMENT INFORMATION

Outputs are driven to a minimum high-logic level of 2.4 V and to a maximum low-logic level of 0.6 V. These levels are compatible with TTL devices.

Output transition times are specified as follows: For a high-to-low transition on either an input or output signal, the level at which the signal is said to be no longer high is 2 V and the level at which the signal is said to be low is 0.8 V. For a low-to-high transition, the level at which the signal is said to be no longer low is 0.8 V and the level at which the signal is said to be high is 2 V, as shown below.

The rise and fall times are not specified but are assumed to be those of standard TTL devices, which are typically 1.5 ns.



test measurement

The test-load circuit shown in Figure 3 represents the programmable load of the tester pin electronics that are used to verify timing parameters of TI380C25 output signals.



Where:	loL	=	2 mA, dc-level verification (all outputs)
	IOH	=	400 μA (all outputs)
	VLOAD	=	1.5 V, typical dc-level verification or
			0.7 V, typical timing verification
	СT	=	65 pF, typical load-circuit capacitance

Figure 3. Test-Load Circuit



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power up, SBCLK, OSCIN, MBCLK1, MBCLK2, SYNCIN, and SRESET timing

NO.				MIN	NOM	MAX	UNIT
100†	t _{r(VDD})	Rise time, 1.2 V to minimum VDD-high level				1	ms
101†‡	td(VDDH-SCKV)	Delay time, minimum VDD-high level to first valid S	BCLK no longer high			1	ms
102†‡	td(VDDH-OSCV)	Delay time, minimum V_{DD} -high level to first value	I OSCIN high			1	ms
103	^t c(SCK)	Cycle time, SBCLK (see Note 13)		30.3		500	ns
104	^t w(SCKH)	Pulse duration, SBCLK high		13		500	ns
105	^t w(SCKL)	Pulse duration, SBCLK low		13		500	ns
106†	^t t(SCK)	Transition time, SBCLK				2	ns
107	tc(OSC)	Cycle time, OSCIN (see Note 14)			1/OSCIN		ns
			OSCIN = 64 MHz	5.5			
108	^t w(OSCH)	Pulse duration, OSCIN high (see Note 15)	OSCIN = 48 MHz	8			ns
			OSCIN = 32 MHz	8			
			OSCIN = 64 MHz	5.5			
109	^t w(OSCL)	Pulse duration, OSCIN low (see Note 15)	OSCIN = 48 MHz	8			ns
			OSCIN = 32 MHz	8			
110†	^t t(OSC)	Transition time, OSCIN				3	ns
111†	td(OSCV-CKV)	Delay time, OSCIN valid to MBCLK1 and MBCL	<2 valid			1	ms
117†	^t h(VDDH-RSL)	Hold time, SRESET low after V _{DD} reaches minir	num high level	5			ms
118†	^t w(RSH)	Pulse duration, SRESET high		14			μs
119†	^t w(RSL)	Pulse duration, SRESET low		14			μs
288†	t _{su(RST)}	Setup time, DMA size to SRESET high (Intel mo	de only)	10			ns
289†	^t h(RST)	Hold time, DMA size from SRESET high (Intel m	ode only)	10			ns
	taa	One-eighth of a local memory cycle	CLKDIV = H	2t _{c(OS0}	C)		
	tM		CLKDIV = L	2t _{c(OS0}	C)		ns

[†]This specification is provided as an aid to board design. It is not assured during manufacturing testing.

[‡] If parameter 101 or 102 cannot be met, parameter 117 must be extended by the larger difference: real value of parameter 101 or 102 minus the max value listed.

NOTES: 13. SBCLK can be any value between 2 MHz to 33 MHz. This data sheet describes the system interface (SIF) timing parameters for the case of SBCLK at 25 MHz and at 33 MHz.

14. The value of OSCIN can be 64 MHz \pm 1%, 32 MHz \pm 1%, or 48 MHz \pm 1%. If OSCIN is used to generate PXTALIN, the OSCIN tolerance must be \pm 0.01%.

15. This is to assure a \pm 5% duty-cycle crystal, provided that OSCIN meets the recommended operating conditions for V_{IH} and V_{IL}.



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NOTE A: In order to represent the information in one illustration, nonactual phase and timebase characteristics are shown. Refer to specified parameters for precise information.





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memory-bus timing: local-memory clocks, MAL, MROMEN, MBIAEN, NMI, MRESET, and ADDRESS

 t_{M} is the cycle time of one-eighth of a local-memory cycle (31.25 ns minimum for a 4-MHz local bus or 20.83 ns minimum for a 6-MHz local bus).

NO.		MIN	MAX	UNIT
1	Period of MBCLK1 and MBCLK2	4t _M		ns
2	Pulse duration, clock high	2t _M -9		ns
3	Pulse duration, clock low	2t _M -9		ns
4	Hold time, MBCLK2 low after MBCLK1 high	t _M -9		ns
5	Hold time, MBCLK1 high after MBCLK2 high	t _M -9		ns
6	Hold time, MBCLK2 high after MBCLK1 low	t _M -9		ns
7	Hold time, MBCLK1 low after MBCLK2 low	t _M -9		ns
8	Setup time, address/enable on MAX0, MAX2, and MROMEN before MBCLK1 no longer high	t _M -9		ns
9	Setup time, row address on MADL0-MADL7, MAXPH, and MAXPL before MBCLK1 no longer high	t _M -14		ns
10	Setup time, address on MADH0-MADH7 before MBCLK1 no longer high	t _M -14		ns
11	Setup time, MAL high before MBCLK1 no longer high	13		ns
12	Setup time, address on MAX0, MAX2, and MROMEN before MBCLK1 no longer low	0.5t _M -9		ns
13	Setup time, column address on MADL0-MADL7, MAXPH, and MAXPL before MBCLK1 no longer low	0.5t _M -9		ns
14	Setup time, status on MADH0-MADH7 before MBCLK1 no longer low	0.5t _M -9		ns
120	Setup time, MMI valid before MBCLK1 low	30		ns
121	Hold time, NMI valid after MBCLK1 low	0		ns
126	Delay time, MBCLK1 no longer low to MRESET valid	0	20	ns
129	Hold time, column address/status after MBCLK1 no longer low	t _M -7		ns



[†] MBCLK1 and MBCLK2 have no timing relationship to OSCOUT. MBCLK1 and MBCLK2 can start on any OSCIN rising edge, depending on when the memory cycle starts execution.

Figure 5. Clock Waveforms After Clock Stabilization



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Figure 6. Memory-Bus Timing: Local-Memory Clocks, MAL, MROMEN, MBIAEN, NMI, MRESET, and AD DRESS



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memory-bus timing: clocks, MRAS, MCAS, and MAL to ADDRESS

 t_M is the cycle time of one-eighth of a local-memory cycle (31.25 ns minimum for a 4-MHz local bus or 20.83 ns minimum for a 6-MHz local bus).

NO.		MIN	MAX	UNIT
15	Setup time, row address on MADL0–MADL7, MAXPH, and MAXPL before $\overline{\text{MRAS}}$ no longer high	1.5t _M – 11.5		ns
16	Hold time, row address on MADL0–MADL7, MAXPH, and MAXPL after MRAS no longer high	t _M -6.5		ns
17	Delay time, MRAS no longer high to MRAS no longer high in the next memory cycle	8t _M		ns
18	Pulse duration, MRAS low	4.5t _M −5		ns
19	Pulse duration, MRAS high	3.5t _M −5		ns
20	Setup time, column address (MADL0-MADL7, MAXPH, and MAXPL) and status (MADH0-MADH7) before MCAS no longer high	0.5t _M -9		ns
21	Hold time, column address (MADL0-MADL7, MAXPH, and MAXPL) and status (MADH0-MADH7) after MCAS low	t _M -5		ns
22	Hold time, column address (MADL0-MADL7, MAXPH, and MAXPL) and status (MADH0-MADH7) after MRAS no longer high	2.5t _M -6.5		ns
23	Pulse duration, MCAS low	3t _M -9		ns
24	Pulse duration, MCAS high, refresh cycle follows read or write cycle	2t _M -9		ns
25	Hold time, row address on MAXL0-MAXL7, MAXPH, and MAXPL after MAL low	1.5t _M -9		ns
26	Setup time, row address on MAXL0-MAXL7, MAXPH, and MAXPL before $\overline{\text{MAL}}$ no longer high	t _M -9		ns
27	Pulse duration, MAL high	t _M -9		ns
28	Setup time, address/enable on MAX0, MAX2, and MROMEN before MAL no longer high	t _M -9		ns
29	Hold time, address/enable of MAX0, MAX2, and MROMEN after MAL low	1.5t _M -9		ns
30	Setup time, address on MADH0-MADH7 before MAL no longer high	t _M -9		ns
31	Hold time, address on MADH0–MADH7 after MAL low	1.5t _M -9		ns



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Figure 7. Memory-Bus Timing: Clocks, MRAS, MCAS, and MAL to ADDRESS



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memory-bus timing: read cycle

 t_{M} is the cycle time of one-eighth of a local-memory cycle (31.25 ns minimum for a 4-MHz local bus or 20.83 ns minimum for a 6-MHz local bus).

NO.		MIN	MAX	UNIT
32	Access time, address/enable valid on MAX0, MAX2, and MROMEN to valid data/parity		6t _M – 23	ns
33	Access time, address valid on MAXPH, MAXPL, MADH0-MADH7, and MADL0-MADL7 to valid data/parity		6t _M -23	ns
35	Access time, MRAS low to valid data/parity		4.5t _M -21.5	ns
36	Hold time, valid data/parity after MRAS no longer low	0		ns
37†	Hold time, address in the high-impedance state on MAXPH, MAXPL, MADH0-MADH7 and MADL0-MADL7 after MRAS high (see Note 16)	2t _M -10.5		ns
38	Access time, MCAS low to valid data/parity		3t _M -23	ns
39	Hold time, valid data/parity after MCAS no longer low	0		ns
40†	Hold time, address in the high-impedance state on MAXPH, MAXPL, MADH0-MADH7, and MADL0-MADL7 after MCAS high (see Note 16)	2t _M -13		ns
41	Delay time, MCAS no longer high to MOE low		t _M +13	ns
42†	Setup time, address/status in the high-impedance state on MAXPH, MAXPL, MADL0-MADL7, and MADH0-MADH7 before MOE no longer high	0		ns
43	Access time, MOE low to valid data/parity		2t _M -20	ns
44	Pulse duration, MOE low	2t _M -9		ns
45	Delay time, MCAS low to MOE no longer low	3t _M −9		ns
46	Hold time, valid data/parity in after MOE no longer low	0		ns
47†	Hold time, address in the high-impedance state on MAXPH, MAXPL, MADH0–MADH7, and MADL0–MADL7 after MOE high (see Note 16)	2t _M -15		ns
48†	Setup time, address/status in the high-impedance state on MAXPH, MAXPL, MADL0-MADL7, and MADH0-MADH7, before MBEN no longer high	0		ns
48a†	Setup time, address/status in the high-impedance state on MAXPH, MAXPL, MADL0-MADL7, and MADH0-MADH7 and before MBIAEN no longer high	0		ns
49	Access time, MBEN low to valid data/parity		2t _M -25	ns
49a	Access time, MBIAEN low to valid data/parity		2t _M -25	ns
50	Pulse duration, MBEN low	2t _M -9		ns
50a	Pulse duration, MBIAEN low	2t _M -9		ns
51	Hold time, valid data/parity after MBEN no longer low	0		ns
51a	Hold time, valid data/parity after MBIAEN no longer low	0		ns
52†	Hold time, address in the high-impedance state on MAXPH, MAXPL, MADH0-MADH7, and MADL0-MADL7 after MBEN high (see Note 16)	2t _M -15		ns
52a†	Hold time, address in the high-impedance state on MAXPH, MAXPL, MADH0-MADH7, and MADL0-MADL7 after MBIAEN high	2t _M -15		ns
53	Hold time, MDDIR high after MBEN high, read follows write cycle	1.5t _M -12		ns
54	Setup time, MDDIR low before MBEN no longer high	3t _M -5		ns
55	Hold time, MDDIR low after MBEN high, write follows read cycle	3t _M -12		ns

⁺ This specification has been characterized to meet stated value. It is not assured during manufacturing testing.

NOTE 16: The data/parity that exists on the address lines will most likely reach the high-impedance state sometime later than the rising edge of MRAS, MCAS, MOE, or MBEN (between MIN and MAX of timing parameter 36) and will be a function of the memory being read. The MIN time given represents the time from the rising edge of MRAS, MCAS, MOE, or MBEN to the beginning of the next address, and does not represent the actual high-impedance period on the address bus.



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Figure 8. Memory-Bus Timing: Read Cycle



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memory-bus timing: write cycle

 t_{M} is the cycle time of one-eighth of a local-memory cycle (31.25 ns minimum for a 4-MHz local bus or 20.83 ns minimum for a 6-MHz local bus).

NO.		MIN	MAX	UNIT
58	Setup time, MW low before MRAS no longer low	tM		ns
60	Setup time, MW low before MCAS no longer low	1.5t _M -6.5		ns
63	Setup time, valid data/parity before MW no longer high	5.1		ns
64	Pulse duration, MW low	2.5t _M -9		ns
65	Hold time, data/parity out valid after MW high	0.5t _M -10.5		ns
66	Setup time, address valid on MAX0, MAX2, and MROMEN before MW no longer low	7t _M -11.5		ns
67	Hold time, MRAS low to MW no longer low	5.5t _M -9		ns
69	Hold time, MCAS low to MW no longer low	4t _M -11.5		ns
70	Setup time, MBEN low before MW no longer high	1.5t _M -13.5		ns
71	Hold time, MBEN low after MW high	0.5t _M -6.5		ns
72	Setup time, MDDIR high before MBEN no longer high	2t _M -9		ns
73	Hold time, MDDIR high after MBEN high	1.5t _M -12		ns



Figure 9. Memory-Bus Timing: Write Cycle


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memory-bus timing: DRAM-refresh timing

 t_{M} is the cycle time of one-eighth of a local-memory cycle (31.25 ns minimum for a 4-MHz local bus or 20.83 ns minimum for a 6-MHz local bus).

NO.		MIN	MAX	UNIT
15	Setup time, row address on MADL0-MADL7, MAXPH, and MAXPL before MRAS no longer high	1.5t _M - 11.5		ns
16	Hold time, row address on MADL0–MADL7, MAXPH, and MAXPL after MRAS no longer high	t _M -6.5		ns
18	Pulse duration, MRAS low	4.5t _M -5		ns
19	Pulse duration, MRAS high	3.5t _M -5		ns
73a	Setup time, MCAS low before MRAS no longer high	1.5t _M -11.5		ns
73b	Hold time, MCAS low after MRAS low	4.5t _M -6.5		ns
73c	Setup time, MREF high before MCAS no longer high	14		ns
73d	Hold time, MREF high after MCAS high	t _M -9		ns



Figure 10. Memory-Bus Timing: DRAM-Refresh Cycle

XMATCH and XFAIL timing

 t_{M} is the cycle time of one-eighth of a local-memory cycle (31.25 ns minimum for a 4-MHz local bus or 20.83 ns minimum for a 6-MHz local bus).

NO.		MIN	MAX	UNIT
127	Delay time, status bit 7 high to XMATCH and XFAIL recognized	7t _M		ns
128	Pulse duration, XMATCH or XFAIL high	50		ns



Figure 11. XMATCH and XFAIL Timing



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token ring: ring-interface timing

NO.			MIN	TYP MAX	UNIT
153	Pariad of PCLK (and Note 17)	4Mbps		125	ns
153	 Period of RCLK (see Note 17) Pulse duration, RCLK low Pulse duration, RCLK high Setup time, RCVR valid before rising edge (1.8 V) of RCLK at 16 N Hold time, RCVR valid after rising edge (1.8 V) of RCLK at 16 N Pulse duration, ring baud clock low 	16 Mbps		31.25	ns
154L	Pulse duration, PCLK low	4Mbps 125 16 Mbps 31.25 4 Mbps nominal: 62.5 ns 46 16 Mbps nominal: 15.625 ns 15 4 Mbps nominal: 62.5 ns 35 16 Mbps nominal: 62.5 ns 35 16 Mbps nominal: 15.625 ns 8 at 16 Mbps 10 6 Mbps 4 4 Mbps 40 16 Mbps 40 16 Mbps 8 4 Mbps 125 16 Mbps (for PXTALIN only) 31.25		ns	
154L	Pulse duration, RCLK low	16 Mbps nominal: 15.625 ns	15		ns
45411	Pulse duration DCLK high	4 Mbps nominal: 62.5 ns	125 is 31.25 nominal: 62.5 ns 46 is nominal: 15.625 ns 15 is nominal: 62.5 ns 35 is nominal: 15.625 ns 8 10 4 40 40 is 8 40 8 51 8 52 125 53 125 53 125 53 125	ns	
154H		16 Mbps nominal: 15.625 ns	8		ns
155	Setup time, RCVR valid before rising edge (1.8 V) of RCLK at 1	6 Mbps	ops 10		
156	Hold time, RCVR valid after rising edge (1.8 V) of RCLK at 16 N	<i>l</i> lbps	4		ns
158L	Dulas duration, ring haud alook low	4 Mbps	40		ns
199F	Pulse duration, hing baud clock low	16 Mbps	8		ns
158H	Dulas duration, ring houd alook high	4 Mbps	40		ns
	Pulse duration, hing baud clock high	16 Mbps	8		ns
465	Deried of OCCULT and DVTALIN (see Note 17)	CLK at 16 Mbps 4 Mbps 16 Mbps 4 Mbps 16 Mbps 16 Mbps 4 Mbps 4 Mbps 4 Mbps		125	ns
165	Period of OSCOUT and PXTALIN (see Note 17)	16 Mbps (for PXTALIN only)		31.25	ns
	Tolerance of PXTALIN input frequency (see Note 17)			± 0.01	%

NOTE 17: This parameter is not tested but is required by the IEEE 802.5 specification.



Figure 12. Ring-Interface Timing



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NO.			MIN	MAX	UNIT
159	^t sk(DR)	Delay from DRVR rising edge $(1.8 V)$ to DRVR falling edge $(1 V)$ or DRVR falling edge $(1 V)$ to DRVR rising edge $(1.8 V)$		±2	ns
160	^t d(DR)H [†]	Delay from RCLK (or PXTALIN) falling edge (1 V) to DRVR rising edge (1.8 V)	See Not	te 18	ns
161	^t d(DR)L [†]	Delay from RCLK (or PXTALIN) falling edge (1 V) to DRVR falling edge (1 V)	See Not	te 18	ns
162	^t d(DRN)H [†]	Delay from RCLK (or PXTALIN) falling edge (1 V) to $\overline{\text{DRVR}}$ falling edge (1 V)	See Not	te 18	ns
163	^t (DRN)L [†]	Delay from RCLK (or PXTALIN) falling edge (1 V) to $\overline{\text{DRVR}}$ rising edge (1.8 V)	See Not	te 18	ns
164	DRVR / DRVR asymmetry	$\frac{t_{d(DR)L} + t_{d(DRN)H}}{2} - \frac{t_{d(DR)H} + t_{d(DRN)L}}{2}$		±1.5	ns

token ring: transmitter timing

[†] When in active-monitor mode, the clock source is PXTALIN; otherwise, the clock source is either RCLK or PXTALIN.

NOTE 18: This parameter is not tested to a minimum or a maximum but is measured and used as a component required for parameter 164.



Figure 13. Skew and Asymmetry From RCLK or PXTALIN to DRVR and DRVR



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80x8x DIO read-cycle timing

NO.		25-MHz	z OPERATION	33-MH	z OPERATION	UNIT
NO.		MIN	MAX	MIN	MAX	UNIT
255	Delay time, SRDY low to either SCS or SRD high	15		15		ns
256	Pulse duration, SRAS high	30		30		ns
259†	Hold time, SAD in the high-impedance state after SRD low (see Note 19)	0		0		ns
260	Setup time, SAD <u>H0</u> –SADH7, SADL0–SADL7, SPH, and SPL valid before SRDY low	0		0		ns
261†	Delay time, SRD or SCS high to SAD in the high-impedance state (see Note 19)		35		35	ns
261a	Hold time, output data valid after SRD or SCS high (see Note 19)	0		0		ns
264	Setup time, SRSX, SRS0-SRS2, SCS, and SBHE valid to SRAS no longer high (see Note 20)	30		30		ns
265	Hold time, SRSX, SRS0-SRS2, SCS, and SBHE valid after SRAS low	10		10		ns
266a	Setup time, SRAS high to SRD no longer high (see Note 20)	15		15		ns
267‡	Setup time, SRSX, SRS0-SRS2 valid before SRD no longer high (see Note 19)	15		15		ns
268	Hold time, SRSX, SRS0–SRS2 valid after SRD no longer low (see Note 20)	0		0		ns
272a	Setup time, SRD, SWR, and SIACK high from previous cycle to SRD no longer high	^t c(SCK)		^t c(SCK)		ns
273a	Hold time, SRD, SWR, and SIACK high after SRD high	^t c(SCK)		^t c(SCK)		ns
275	Delay time, SRD and SWR, or SCS high to SRDY high (see Note 19)	0	25	0	25	ns
279†	Delay time, SRD and SWR, high to SRDY in the high-impedance state	0	^t c(SCK)	0	^t c(SCK)	ns
282a	Delay time, SDBEN low to SRDY low in a read cycle	0	t _{c(SCK)} / 2 + 4	0	t _{c(SCK)} / 2 + 4	ns
282R	Delay time, SRD low to SDBEN low (see <i>TMS380 Second Generation Token-Ring User's Guide</i> , SPWU005, subsection 3.4.1.1.1), provided previous cycle completed	0	t _{c(SCK)} + 3	0	^t c(SCK) + 3	ns
283R	Delay time, SRD high to SDBEN high (see Note 19)	0	t _{c(SCK)} / 2 + 4	0	t _{c(SCK)} / 2 + 4	ns
286	Pulse duration, SRD high between DIO accesses (see Note 19)	^t c(SCK)		^t c(SCK)	, ,	ns

[†] This specification is provided as an aid to board design. It is not assured during manufacturing testing.

[‡] It is the later of SRD and SWR or SCS low that indicates the start of the cycle.

NOTES: 19. The inactive chip select is SIACK in DIO read and DIO write cycles, and SCS is the inactive chip select in interrupt-acknowledge cycles.

20. In 80x8x mode, SRAS can be used to strobe the values of SBHE, SRSX, SRS0 – SRS2, and SCS. When used to do so, SRAS must meet parameter 266a, and SBHE, SRS0–SRS2, and SCS must meet parameter 264. If SRAS is strapped high, parameters 266a and 264 are irrelevant and parameter 268 must be met.



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[†] In 80x8x mode, SRAS can be used to strobe the values of SBHE, SRSX, SRS0–SRS2, and SCS. When used to do so, SRAS must meet parameter 266a, and SBHE, SRS0–SRS2, and SCS must meet parameter 264. If SRAS is strapped high, parameters 266a and 264 are irrelevant and parameter 268 must be met.

[‡] When the TMS380C25 begins to drive SDBEN inactive, it has already latched the write data internally. Parameter 263 must be met to the input of the data buffers.

§ In 8-bit 80x8x mode DIO reads, the SADH0-SADH7 contain don't care data.

Figure 14. 80x8x DIO Read-Cycle Timing



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80x8x DIO write-cycle timing

NO.			25-MH	z OPERATION	33-MH	z OPERATION	UNIT
NO.			MIN	MAX	MIN	MAX	UNIT
255	Delay time, SRDY low to either SCS or SW	R high	15		15		ns
256	Pulse duration, SRAS high		30		30		ns
262	Setup time, <u>SADH0-SADH7</u> , SADL0-SAD valid before SCS or SWR no longer low	DL7, SPH, and SPL	15		15		ns
263	Hold time, <u>SADH0-SADH7</u> , SADL0-SAD valid after SCS or SWR high	L7, SPH, and SPL	15		15		ns
264	Setup time, SRSX, SRS0–SRS2, SCS, and longer high (see Note 20)	SBHE to SRAS no	30		30		ns
265	Hold time, SRSX, SRS0-SRS2, SCS, and low	SBHE after SRAS	10		10		ns
266a	Setup time, SRAS high to SWR no longer hi	igh (see Note 19)	15		15		ns
267†	Setup time, SRSX, SRS0-SRS2 before \overline{S} (see Note 19)	WR no longer high	15		15		ns
268	Hold time, SRSX, SRS0-SRS2 valid after (see Note 20)	SWR no longer low	0		0		ns
272a	Setup time, SRD, SWR, and SIACK high fro SWR no longer high	m previous cycle to	^t c(SCK)		^t c(SCK)		ns
273a	Hold time, SRD, SWR, and SIACK high afte	r SWR high	^t c(SCK)		t _{c(SCK)}		ns
276‡	Delay time, SRDY low in the first DIO access to SRDY low in the immediately following acc <i>TMS380 Second-Generation Token Riv</i> SPWU005, subsection 3.4.1.1.1)	cess to the SIF (see		4000		4000	ns
275	Delay time, SWR or SCS high to SRDY high	n (see Note 19)	0	25	0	25	ns
279§	Delay time, SWR high to SRDY in the high-	mpedance state	0	^t c(SCK)	0	^t c(SCK)	ns
280	Delay time, SWR low to SDDIR low (see No	ote 19)	0	t _{c(SCK)} / 2 + 4	0	t _{c(SCK)} / 2 + 4	ns
282b	Delay time, SDBEN low to SRDY low (see TMS380 Second Generation Token-Ring	If SIF register is ready (no waiting required)	0	t _{c(SCK)} / 2 + 4	0	t _{c(SCK)} / 2 + 4	ns
2020	User's Guide, SPWU005, subsection 3.4.1.1.1)	If SIF register is not ready (waiting required)	0	4000	0	4000	113
282W	Delay time, SDDIR low to SDBEN low		0	t _{c(SCK)} / 2 + 4	0	t _{c(SCK)} / 2 + 4	ns
283W	Delay time, SCS or SWR high to SDBEN no	longer low	0	t _{c(SCK)} / 2 + 4	0	t _{c(SCK)} / 2 + 4	ns
286	Pulse duration, SWR high between DIO acce	esses (see Note 19)	^t c(SCK)		t _{c(SCK)}		ns

[†] It is the later of SRD and SWR or SCS low that indicates the start of the cycle.

[‡] This specification has been characterized to meet stated value. It is not assured during manufacturing testing.

§ This specification is provided as an aid to board design. It is not assured during manufacturing testing.

NOTES: 19. The inactive chip select is SIACK in DIO read and DIO write cycles, and SCS is the inactive chip select in interrupt-acknowledge cycles.

20. In 80x8x mode, SRAS can be used to strobe the values of SBHE, SRSX, SRS0–SRS2, and SCS. When used to do so, SRAS must meet parameter 266a, and SBHE, SRS0–SRS2, and SCS must meet parameter 264. If SRAS is strapped high, parameters 266a and 264 are irrelevant and parameter 268 must be met.



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[†] When the TMS380C25 begins to drive SDBEN inactive, it has already latched the write data internally. Parameter 263 must be met to the input of the data buffers.

[‡] In 8-bit 80x8x-mode DIO writes, the value placed on SADH0–SADH7 is a don't care.

Figure 15. 80x8x DIO Write-Cycle Timing



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80x8x interrupt-acknowledge-cycle timing: first SIACK pulse

NO.		25-MI OPERA		33-MI OPERA		UNIT
		MIN	MAX	MIN	MAX	
286	Pulse duration, SIACK high between DIO accesses (see Note 19)	^t c(SCK)		^t c(SCK)		ns
287	Pulse duration, SIACK low on first pulse of two pulses	^t c(SCK)		^t c(SCK)		ns

NOTE 19: The inactive chip select is SIACK in DIO read and DIO write cycles, and SCS is the inactive chip select in interrupt acknowledge cycles.



Figure 16. 80x8x Interrupt-Acknowledge-Cycle Timing: First SIACK Pulse

80x8x interrupt-acknowledge-cycle timing: second SIACK pulse

NO.		25-MH	OPERATION	33-MH	z OPERATION	UNIT
NO.		MIN	MAX	MIN	MAX	UNIT
255	Delay time, SRDY low to SCS high	15		15		ns
259†	Hold time, SAD in the high-impedance state after SIACK low (see Note 19)	0		0		ns
260	Setup time, output data valid before SRDY low	0		0		ns
261†	Delay time, SIACK high to SAD in the high-impedance state (see Note 19)		35		35	ns
261a	Hold time, output data valid after SIACK high (see Note 19)	0		0		ns
272a	Setup time, inactive data strobe high to SIACK no longer high	^t c(SCK)		^t c(SCK)		ns
273a	Hold time, inactive data strobe high after SIACK high	^t c(SCK)		^t c(SCK)		ns
275	Delay time, SIACK high to SRDY high (see Note 19)	0	25	0	25	ns
276‡	Delay time, SRDY low in the first DIO access to the SIF register to SRDY low in the immediately following access to the SIF		4000		4000	ns
279†	Delay time, SIACK high to SRDY in the high-impedance state	0	^t c(SCK)	0	^t c(SCK)	ns
282a	Delay time, SDBEN low to SRDY low in a read cycle	0	t _{c(SCK)} / 2 + 4	0	t _{c(SCK)} / 2 + 4	ns
282R	Delay time, SIACK low to SDBEN low (see <i>TMS380 Second Generation Token-Ring User's Guide</i> , SPWU005, subsection 3.4.1.1.1), provided previous cycle completed	0	^t c(SCK) + 3	0	t _{c(SCK)} + 3	ns
283R	Delay time, SIACK high to SDBEN high (see Note 19)	0	t _{c(SCK)} / 2 + 4	0	t _{c(SCK)} / 2 + 4	ns

[†] This specification is provided as an aid to board design. It is not assured during manufacturing.

[‡] This specification has been characterized to meet stated value. It is not assured during manufacturing.

NOTE 19: The inactive chip select is SIACK in DIO read and DIO write cycles, and SCS is the inactive chip select in interrupt-acknowledge cycles.



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TRDY is an active-low bus ready signal. It must be asserted before data output.
 In 8-bit 80x8x mode DIO writes, the value placed on SADH0-SADH7 is a don't care.

Figure 17. 80x8x Interrupt-Acknowledge-Cycle Timing: Second SIACK Pulse



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80x8x-mode bus-arbitration timing, SIF takes control

NO.		25-MH OPERAT	-	33-MHz OPERATION		UNIT
		MIN	MAX	MIN	MAX	
208a	Setup time, asynchronous signal SBBSY and SHLDA before SBCLK no longer high to assure recognition on that cycle	10		10		ns
208b	Hold time, asynchronous signal SBBSY and SHLDA after SBCLK low to assure recognition on that cycle	10		10		ns
212	Delay time, SBCLK low to SADH0-SADH7, SADL0-SADL7, SPH, and SPL valid		20		20	ns
224a	Delay time, SBCLK low in cycle I2 to SOWN low	0	20	0	15	ns
224c	Delay time, SBCLK low in cycle I2 to SDDIR low in DMA read		28		23	ns
230	Delay time, SBCLK high to SHRQ high		20		15	ns
241	Delay time, SBCLK high in TX cycle to $\overline{\text{SRD}}$ and $\overline{\text{SWR}}$ high, bus acquisition		25		25	ns
241a [†]	Hold time, SRD and $\overline{\text{SWR}}$ in the high-impedance state after $\overline{\text{SOWN}}$ low, bus acquisition	^t c(SCK)-15		^t c(SCK)-15		ns

[†] This specification has been characterized to meet stated value. It is not assured during manufacturing testing.





[†] While the system interface DMA controls are active (i.e., SOWN is asserted), SCS is disabled.

Figure 18. 80x8x-Mode Bus-Arbitration Timing, SIF Takes Control



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80x8x-mode DMA read-cycle timing

NO		25-MHz OI	PERATION	33-MHz O	PERATION	
NO.		MIN	MAX	MIN	MAX	UNIT
205	Setup time, SADL0-SADL7, SADH0-SADH7, SPH, and SPL valid before SBCLK in T3 cycle no longer high	10		10		ns
206	Hold time, SADL0-SADL7, SADH0-SADH7, SPH, and SPL valid after SBCLK low in T4 cycle if parameters 207a and 207b not met	10		10		ns
207a	Hold time, SADL0-SADL7, SADH0-SADH7, SPH, and SPL valid after SRD high	0		0		ns
207b	Hold time, SADL0- <u>SADL7</u> , SADH0-SADH7, SPH, and SPL valid after SDBEN no longer low	0		0		ns
208a	Setup time, asynchronous signal SRDY before SBCLK no longer high to assure recognition on this cycle	10		10		ns
208b	Hold time, asynchronous signal SRDY after SBCLK low to assure recognition on this cycle	10		10		ns
212	Delay time, SBCLK low to address valid		20		20	ns
214†	Delay time, SBCLK low in T1 cycle to SADH0-SADH7, SADL0-SADL7, SPH, and SPL in the high-impedance state		20		15	ns
216	Delay time, SBCLK high to SALE or SXAL high		20		20	ns
216a	Hold time, SALE or SXAL low after SRD high	0		0		ns
217	Delay time, SBCLK high to SXAL low in the TX cycle or SALE low in the T1 cycle	0	25	0	25	ns
218	Hold time, SADH0-SADH7, SADL0-SADL7, SPH, and SPL valid after SALE or SXAL low	^t w(SCKH) ⁻¹⁵	t _{c(SCK)} /2-4	tw(SCKH)-15	t _{c(SCK)} /2-4	ns
223R	Delay time, SBCLK low in T4 cycle to SRD high (see Note 21)	0	16	0	11	ns
225R	Delay time, SBCLK low in T4 cycle to SDBEN high		16		11	ns
226†	Delay time, SADH0-SADH7, SADL0-SADL7, SPH, and SPL in the high-impedance state to SRD low	0		0		ns
227R	Delay time, SBCLK low in T2 cycle to SRD low	0	15	0	15	ns
229†	Hold time, SADH0-SADH7, SADL0-SADL7, SPH, and SPL in the high-impedance state after SBCLK low in T1 cycle	0		0		ns
231	Pulse duration, SRD low	2t _{c(SCK)} -25		2t _{c(SCK)} -25		ns
233	Setup time, SADH0-SADH7, SADL0-SADL7, SPH, and SPL valid before SALE, SXAL no longer high	10		10		ns
237R	Delay time, SBCLK high in the T2 cyle to SDBEN low		16		11	ns
247	Setup time, data valid before SRDY low if parameter 208a not met	0		0		ns

[†] This specification has been characterized to meet stated value. It is not assured during manufacturing testing.

NOTE 21: While the system-interface DMA controls are active (i.e., SOWN is asserted), SCS is disabled.





[‡] Motorola-style bus slaves hold SDTACK active until the bus master deasserts SAS.

§ In 8-bit 80x8x mode, the most significant byte of the address is maintained on SADH for T2, T3, and T4. The address is maintained according to parameter 21; i.e., held after T4 high. If parameter 208A is not met, valid data must be present before SRDY goes low.

Figure 19. 80x8x-Mode DMA Read-Cycle Timing

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80x8x-mode DMA write-cycle timing

NO		25-MHz OI	PERATION	33-MHz O	PERATION	
NO.		MIN	MAX	MIN	MAX	UNIT
208a	Setup time, asynchronous signal SRDY before SBCLK no longer high to assure recognition on that cycle	10		10		ns
208b	Hold time, asynchronous signal SRDY after SBCLK low to assure recognition on that cycle	10		10		ns
212	Delay time, SBCLK low to SADH0-SADH7, SADL0-SADL7, SPH, and SPL valid		20		20	ns
216	Delay time, SBCLK high to SALE or SXAL high		20		20	ns
216a	Hold time, SALE or SXAL low after SWR high	0		0		ns
217	Delay time, SBCLK high to SXAL low in the TX cycle or SALE low in the T1 cycle	0	25	0	25	ns
218	Hold time, address valid after SALE, SXAL low	tw(SCKH)-15	t _{c(SCK)} /2-4	tw(SCKH)-15	t _{c(SCK)} /2-4	ns
219	Delay time, SBCLK low in T2 cycle to output data and parity valid		29		29	ns
221	Hold time, SADH0-SADH7, SADL0-SADL7, SPH, and SPL valid after SWR high	t _{c(SCK)} -12		t _{c(SCK)} -12		ns
223W	Delay time, SBCLK low to SWR high	0	16	0	11	ns
225W	Delay time, SBCLK high in T4 cycle to SDBEN high		16		11	ns
225WH	Hold time, SDBEN low after SWR, SUDS, and SLDS high	t _{c(SCK)} /2-7		t _{c(SCK)} /2-7		ns
227W	Delay time, SBCLK low in T2 cycle to SWR low	0	20	0	15	ns
233	Setup time, SADH0-SADH7, SADL0-SADL7, SPH, and SPL valid before SALE, SXAL no longer high	10		10		ns
237W	Delay time, SBCLK high in T1 cycle to SDBEN low		16		11	ns





[†] In 8-bit 80x8x mode, SBHE/SRNW is a don't care input during DIO and an inactive (high) output during DMA. [‡] In 8-bit 80x8x mode, the most significant byte of the address is maintained on SADH for T2, T3, and T4. The address is maintained according to parameter 21; i.e., held after T4 high.

Figure 20. 80x8x-Mode DMA Write-Cycle Timing

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80x8x-mode bus-arbitration timing, SIF returns control

NO.			1Hz ATION	33-MHz OPERATION		UNIT
		MIN	MAX	MIN	MAX	
220†	Delay time, SBCLK low in I1 cycle to SADH0-SADH7, SADL0-SADL7, SPL, SPH, SRD, and SWR in the high-impedance state		35		35	ns
223b†	Delay time, SBCLK low in I1 cycle to SBHE in the high-impedance state		45		45	ns
224b	Delay time, SBCLK low in cycle I2 to SOWN high	0	20	0	15	ns
224d	Delay time, SBCLK low in cycle I2 to SDDIR high		27		22	ns
230	Delay time, SBCLK high in cycle I1 to SHRQ low		20		15	ns
240†	Setup time, $\overline{\text{SRD}},\overline{\text{SWR}},$ and $\overline{\text{SBHE}}$ in the high-impedance state before $\overline{\text{SOWN}}$ no longer low	0		0		ns

[†]This specification has been characterized to meet stated value. It is not assured during manufacturing testing.



In 80x8x mode, the system interface deasserts SHRQ on the rising edge of SBCLK following the T4 state of the last system bus transfer it controls. In 68xxx mode, the system interface deasserts SBRQ on the rising edge of SBCLK in state T2 of the first system bus transfer it controls.
 While the system-interface DMA controls are active (i.e., SOWN is asserted), SCS is disabled.

Figure 21. 80x8x-Mode Bus-Arbitration Timing, SIF Returns Control



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80x8x-mode bus-release timing

NO.		25-N OPER		33-N OPERA	UNIT	
		MIN	MAX	MIN	MAX	
208a	Setup time, asynchronous input $\overline{\mbox{SBRLS}}$ low before SBCLK no longer high to assure recognition	10		10		ns
208b	Hold time, asynchronous input SBRLS low after SBCLK low to assure recognition	10		10		ns
208c	Hold time, SBRLS low after SOWN high	0		0		ns



- NOTES: A. The system interface ignores the assertion of SBRLS if it does not own the system bus. If it does own the bus, when it detects the assertion of SBRLS, it completes any internally started DMA cycle and relinquishes control of the bus. If no DMA transfer has internally started, the system interface releases the bus before starting another.
 - B. If SBERR is asserted when the system interface controls the system bus, the current bus transfer is completed regardless of the value of SRDY. If the BERETRY register is nonzero, the cycle is retried. If the BERETRY register is zero, the system interface releases control of the system bus. The system interface ignores the assertion of SBERR if it is not performing a DMA bus cycle on the system bus. When SBERR is properly asserted and BERETRY is zero, the system interface releases the bus upon completion of the current bus transfer and halts all further DMA on the system side. The error is synchronized to the local bus and DMA stops on the local sides. The value of the SDMAADR, SDMADDRX, and SDMALEN registers in the system interface are not defined after a system-bus error.
 - C. In cycle-steal mode, state TX is present on every system bus transfer. In burst mode, state TX is present on the first bus transfer and whenever the increment of the DMA address register carries beyond the least significant 16 bits.
 - D. SDTACK is not sampled to verify that it is deasserted.
 - E. Unless otherwise specified, for all signals specified as a maximum delay from the end of an SBCLK transition to the signal valid, the signal is also specified to hold its previous value (including high impedance) until the start of that SBCLK transition.

Figure 22. 80x8x-Mode Bus-Release Timing



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68xxx DIO read-cycle timing

NO.		25-MHz	OPERATION	33-MHz	OPERATION	UNIT
NU.		MIN	MAX	MIN	MAX	UNIT
255	Delay time, SDTACK low to either SCS, SUDS, or SLDS high	15		15		ns
259†	Hold time, SAD in the high-impedance state after SUDS or SLDS low (see Note 19)	0		0		ns
260	Setup time, <u>SADH0</u> -SADH7, SADL0-SADL7, SPH, and SPL valid before SDTACK low	0		0		ns
261†	Delay time, SCS, SUDS, or SLDS high to SADH0–SADH7, SADL0–SADL7, SPH, and SPL in the high-impedance state (see Note 19)		35		35	ns
261a	Hold time, output data valid after SUDS or SLDS no longer low (see Note 19)	0		0		ns
267	Setup time, register address before SUDS or SLDS no longer high (see Note 19)	15		15		ns
268	Hold time, register address valid after SUDS or SLDS no longer low (see Note 20)	0		0		ns
272	Setup time, SRNW before SUDS or SLDS no longer high (see Note 19)	12		12		ns
273	Hold time, SRNW after SUDS or SLDS high	0		0		ns
273a	Hold time, SIACK high after SUDS or SLDS high	^t c(SCK)		t _{c(SCK)}		ns
275	Delay time, SCS, SUDS, or SLDS high to SDTACK high (see Note 19)	0	25	0	25	ns
276‡	Delay time, SDTACK low in the first DIO access to the SIF register to SDTACK low in the immediately following access to the SIF		4000		4000	ns
279†	Delay time, SUDS or SLDS high to SDTACK in the high-impedance state	0	^t c(SCK)	0	^t c(SCK)	ns
282a	Delay time, SDBEN low to SDTACK low	0	t _{c(SCK)} /2 + 4	0	$t_{c(SCK)}/2 + 4$	ns
282R	Delay time, SUDS or SLDS low to SDBEN low (see <i>TMS380</i> Second Generation Token-Ring User's Guide, SPWU005, subsection 3.4.1.1.1) provided the previous cycle completed	0	t _{c(SCK)} +3	0	t _{c(SCK)} +3	ns
283R	Delay time, SUDS or SLDS high to SDBEN high (see Note 19)	0	t _{c(SCK)} /2 + 4	0	t _{c(SCK)} /2+4	ns
286	Pulse duration, SUDS or SLDS high between DIO accesses (see Note 19)	^t c(SCK)		t _{c(SCK)}		ns

[†] This specification is provided as an aid to board design. It is not assured during manufacturing testing.

[‡] This specification has been characterized to meet stated value. It is not assured during manufacturing testing. NOTES: 19. The inactive chip select is SIACK in DIO read and DIO write cycles, and SCS is the inactive chip select in interrupt acknowledge cycles.

20. In 80x8x mode, SRAS may be used to strobe the values of SBHE, SRSX, SRS0-SRS2, and SCS. When used to do so, SRAS must meet parameter 266a, and SBHE, SRS0-SRS2, and SCS must meet parameter 264. If SRAS is strapped high, parameters 266a and 264 are irrelevant and parameter 268 must be met.



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Figure 23. 68xxx DIO Read-Cycle Timing



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68xxx DIO write-cycle timing

NO.			25-MHz	OPERATION	33-MHz	OPERATION	UNIT
NO.			MIN	MAX	MIN	MAX	UNIT
255	Delay time, SDTACK low to either SCS, SUI	DS or SLDS high	15		15		ns
262	Setup time, write data valid before SUDS or	SLDS no longer low	15		15		ns
263	Hold time, write data valid after SUDS or SL	DS high	15		15		ns
267†	Setup time, register address before SUDS high (see Note 19)	or SLDS no longer	15		15		ns
268	Hold time, register address valid after SUDS low (see Note 20)	or SLDS no longer	0		0		ns
272	Setup time, SRNW before SUDS or SLDS n (see Note 19)	o longer high	12		12		ns
272a	Setup time, inactive SUDS or SLDS high to a longer high	ctive data strobe no	^t c(SCK)		^t c(SCK)		ns
273	Hold time, SRNW after SUDS or SLDS high		0		0		ns
273a	Hold time, inactive SUDS or SLDS high afte high	r active data strobe	^t c(SCK)		^t c(SCK)		ns
275	Delay time, SCS, SUDS or SLDS high to SE (see Note 19)	DTACK high	0	25	0	25	ns
276‡	Delay time, SDTACK low in the first DIO access to SDTACK low in the immediately following			4000		4000	ns
279§	Delay time, SUDS or SLDS high to SDTACK high-impedance state	k in the	0	^t c(SCK)	0	^t c(SCK)	ns
280	Delay time, SUDS or SLDS low to SDDIR lo	w (see Note 19)	0	$t_{c(SCK)}/2 + 4$	0	$t_{c(SCK)}/2 + 4$	ns
282b	Delay time, SDBEN low to SDTACK low (see TMS380 Second Generation Token-	If SIF register is ready (no waiting required)	0	^t c(SCK) ^{/2} + 4	0	t _{c(SCK)} /2+4	ns
2020	3.4.1.1.1) not	If SIF register is not ready (waiting required)	0	4000	0	4000	115
282W	Delay time, SDDIR low to SDBEN low		0	t _{c(SCK)} /2 + 4	0	t _{c(SCK)} /2+4	ns
283W	Delay time, SUDS or SLDS high to SDBEN	no longer low	0	t _{c(SCK)} /2 + 4	0	$t_{c(SCK)}/2 + 4$	ns
286	Pulse duration, SUDS or SLDS high betwee (see Note 19)	n DIO accesses	^t c(SCK)		^t c(SCK)		ns

[†] It is the later of SRD and SWR or SCS low that indicates the start of the cycle.

[‡]This specification has been characterized to meet stated value. It is not assured during manufacturing testing.

§ This specification is provided as an aid to board design. It is not assured during manufacturing testing.

NOTES: 19. The inactive chip select is SIACK in DIO read and DIO write cycles, and SCS is the inactive chip select in interrupt-acknowledge cycles.

20. In 80x8x mode, SRAS may be used to strobe the values of SBHE, SRSX, SRS0–SRS2, and SCS. When used to do so, SRAS must meet parameter 266a, and SBHE, SRS0–SRS2, and SCS must meet parameter 264. If SRAS is strapped high, parameters 266a and 264 are irrelevant and parameter 268 must be met.



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⁺ For 68xxx mode, skew between SLDS and SUDS must not exceed 10 ns. Provided this limitation is observed, all events referenced to a data strobe edge use the later occurring edge. Events defined by two data strobes edges, such as parameter 286, are measured between latest and earlier edges.

[‡] When the TMS380C25 begins to drive SDBEN inactive, it has already latched the write data internally. Parameter 263 must be met to the input of the data buffers.

§ SDTACK is an active-low bus ready signal. It must be asserted before data output.

Figure 24. 68xxx DIO Write-Cycle Timing



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68xxx interrupt-acknowledge-cycle timing

NO.		25-MHz	OPERATION	33-MHz	OPERATION	UNIT
NO.		MIN	MAX	MIN	MAX	UNIT
255	Delay time, SDTACK low to either SCS or SUDS, or SIACK high	15		15		ns
259†	Hold time, SAD in the high-impedance state after SIACK no longer high (see Note 19)	0		0		ns
260	Setup time, output data valid before SDTACK no longer high	0		0		ns
261†	Delay time, SIACK high to SAD in the high-impedance state (see Note 19)		35		35	ns
261a	Hold time, output data valid after SCS or SIACK no longer low (see Note 19)	0		0		ns
267§	Setup time, register address before SIACK no longer high (see Note 19)	15		15		ns
272a	Setup time, inactive high SIACK to active data strobe no longer high	^t c(SCK)		^t c(SCK)		ns
273a	Hold time, inactive SRNW high after active data strobe high	^t c(SCK)		^t c(SCK)		ns
275	Delay time, SCS or SRNW high to SDTACK high (see Note 19)	0	25	0	25	ns
276‡	Delay time, SDTACK low in the first DIO access to the SIF register to SDTACK low in the immediately following access to the SIF	0	4000	0	4000	ns
279†	Delay time, SIACK high to SDTACK in the high-impedance state	0	^t c(SCK)	0	^t c(SCK)	ns
282a	Delay time, SDBEN low to SDTACK low in a read cycle	0	t _{c(SCK)} /2 + 4	0	$t_{c(SCK)}/2 + 4$	ns
282R	Delay time, SIACK low to SDBEN low (see <i>TMS380 Second Generation Token-Ring User's Guide</i> , SPWU005, subsection 3.4.1.1.1) provided the previous cycle completed	0	t _{c(SCK)} +3	0	^t c(SCK)+3	ns
283R	Delay time, SIACK high to SDBEN high (see Note 19)	0	$t_{c(SCK)}/2 + 4$	0	$t_{c(SCK)}/2 + 4$	ns
286	Pulse duration, SIACK high between DIO accesses (see Note 19)	^t c(SCK)		^t c(SCK)		ns

[†] This specification is provided as an aid to board design. It is not assured during manufacturing testing.

¹ This specification has been characterized to meet stated value. It is not assured during manufacturing testing.
 ¹ It is the later of SRD and SRD or SCS low that indicates the start of the cycle.
 NOTE 19: The inactive chip select is SIACK in DIO read and DIO write cycles, and SCS is the inactive chip select in interrupt-acknowledge cycles.



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⁺ SDTACK is an active-low bus ready signal. It must be asserted before data output.

‡ Internal logic drives SDTACK high and verifies that it has reached a valid high level before making it a 3-state signal.

Figure 25. 68xxx Interrupt-Acknowledge-Cycle Timing



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68xxx-mode bus-arbitration timing, SIF takes control

NO.			25-MHz OPERATION		33-MHz OPERATION	
		MIN	MAX	MIN	MAX	
208a	Setup time, asynchronous input SBGR before SBCLK no longer high to assure recognition on this cycle	10		10		ns
208b	Hold time, asynchronous input SBGR after SBCLK low to assure recognition on this cycle	10		10		ns
212	Delay time, SBCLK low to address valid	0	20	0	20	ns
224a	Delay time, SBCLK low in cycle I2 to SOWN low (see Note 22)	0	20	0	15	ns
224c	Delay time, SBCLK low in cycle I2 to SDDIR low in DMA read		28		23	ns
230	Delay time, SBCLK high to either SHRQ low or SBRQ high		20		15	ns
241	Delay time, SBCLK high in TX cycle to SUDS and SLDS high		25		25	ns
241a†	Hold time, SUDS, SLDS, SRNW, and SAS in the high-impedance state after SOWN low, bus acquisition	^t c(SCK)-15		^t c(SCK)-15		ns

[†] This specification has been characterized to meet stated value. It is not assured during manufacturing testing.

NOTE 22: Motorola-style bus slaves hold SDTACK active until the bus master deasserts SAS.





Figure 26. 68xxx-Mode Bus-Arbitration Timing, SIF Takes Control

[‡]While the system-interface DMA controls are active (i.e., SOWN is asserted), SCS is disabled.

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68xxx-mode DMA read-cycle timing

NO		25-MHz OI	PERATION	33-MHz O	PERATION	
NO.		MIN	MAX	MIN	МАХ	UNIT
205	Setup time, input data valid before SBCLK in T3 cycle no longer high	10		10		ns
206	Hold time, input data valid after SBCLK low in T4 cycle if parameters 207a and 207b not met	10		10		ns
207a	Hold time, input data valid after data strobe no longer low	0		0		ns
207b	Hold time, input data valid after SDBEN no longer low	0		0		ns
208a	Setup time, asynchronous input SDTACK before SBCLK no longer high to assure recognition on this cycle	10		10		ns
208b	Hold time, asynchronous input SDTACK after SBCLK low to assure recognition on this cycle	10		10		ns
209	Pulse duration, \overline{SAS} , \overline{SUDS} , and \overline{SLDS} high	^t c(SCK)+ ^t w(SCKL) ⁻¹⁸		^t c(SCK)+ t _{w(SCKL)} -18		ns
210	Delay time, SBCLK high in T2 cycle to SUDS and SLDS active		16		11	ns
212	Delay time, SBCLK low to address valid		20		20	ns
214†	Delay time, SBCLK low in T2 cycle to SAD in the high-impedance state		20		15	ns
216	Delay time, SBCLK high to SALE or SXAL high		20		20	ns
216a	Hold time, SALE or SXAL low after SUDS and SAS high	0		0		ns
217	Delay time, SBCLK high to SXAL low in the TX cycle or SALE low in the T1 cycle	0	25	0	25	ns
218	Hold time, address valid after SALE, SXAL low	tw(SCKH)-15	t _{c(SCK)} /2-4	tw(SCKH)-15	t _{c(SCK)} /2-4	ns
222	Delay time, SBCLK high to SAS low		20		15	ns
223R	Delay time, SBCLK low in T4 cycle to SUDS, SLDS, and SAS high (see Note 23)	0	16	0	11	ns
225R	Delay time, SBCLK low in T4 cycle to SDBEN high		16		11	ns
229†	Hold time, SAD in the high-impedance state after SBCLK low in T4 cycle	0		0		ns
233	Setup time, address valid before SALE or SXAL no longer high	10		10		ns
233a	Setup time, address valid before SAS no longer high	tw(SCKL)-15		tw(SCKL)-15		ns
237R	Delay time, SBCLK high in the T2 cycle to SDBEN low		16		11	ns
247	Setup time, data valid before SDTACK low if parameter 208a not met	0		0		ns

[†] This specification has been characterized to meet stated value. It is not assured during manufacturing testing. NOTE 23: While the system-interface DMA controls are active (i.e., SOWN is asserted), SCS is disabled.





[†] On a read cycle, the read strobe remains active until the internal sample of incoming data is completed. Input data may be removed when either the read strobe or SDBEN becomes no longer active.

[‡] If parameter 208a is not met, valid data must be present before SDTACK goes low.

§ Motorola-style bus slaves hold SDTACK active until the bus master deasserts SAS.
 ¶ All V_{SS} pins should be routed to minimize inductance to system ground.

Figure 27. 68xxx-Mode DMA Read-Cycle Timing

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68xxx-mode DMA write-cycle timing

NO.		25-MHz OF	PERATION	33-MHz O	PERATION	LINUT
NO.		MIN	MAX	MIN	MAX	UNIT
208a	Setup time, asynchronous input SDTACK before SBCLK no longer high to assure recognition on this cycle	10		10		ns
208b	Hold time, asynchronous input SDTACK after SBCLK low to assure recognition on this cycle	10		10		ns
209	Pulse duration, \overline{SAS} , \overline{SUDS} , and \overline{SLDS} high	^t c(SCK)+ ^t w(SCKL) ⁻¹⁸		^t c(SCK)+ ^t w(SCKL) ⁻¹⁸		ns
211	Delay time, SBCLK high in T2 cycle to SUDS and SLDS active		25		25	ns
211a	Delay time, output data valid to $\overline{\text{SUDS}}$ and $\overline{\text{SLDS}}$ no longer high	^t w(SCKL) ⁻¹⁵		tw(SCKL)-15		ns
212	Delay time, SBCLK low to address valid		20		20	ns
216	Delay time, SBCLK high to SALE or SXAL high		20		20	ns
216a	Hold time, SALE or SXAL low after SUDS and SAS high	0		0		ns
217	Delay time, SBCLK high to SXAL low in the TX cycle or SALE low in the T1 cycle	0	25	0	25	ns
218	Hold time, address valid after SALE, SXAL low	tw(SCKH)-15	t _{c(SCK)} /2-4	tw(SCKH)-15	t _{c(SCK)} /2-4	ns
219	Delay time, SBCLK low in T2 cycle to output data and parity valid		29		29	ns
221	Hold time, output data, parity valid after SUDS and SLDS high	t _{c(SCK)} -12		t _{c(SCK)} -12		ns
222	Delay time, SBCLK high to SAS low		20		15	ns
223W	Delay time, SBCLK low to SUDS, SLDS, and SAS high	0	16	0	11	ns
225W	Delay time, SBCLK high in T4 cycle to SDBEN high		16		11	ns
225WH	Hold time, SDBEN low after SUDS and SLDS high	t _{c(SCK)} /2-7		t _{c(SCK)} /2-7		ns
233	Setup time, address valid before SALE or SXAL no longer high	10		10		ns
233a	Setup time, address valid before SAS no longer high	tw(SCKL)-15		tw(SCKL)-15		ns
237W	Delay time, SBCLK high in T1 cycle to SDBEN low		16	, <u>,</u>	11	ns





 $^{\dagger}_{}$ All VSS pins should be routed to minimize inductance to system ground.

⁺ On a read cycle, the read strobe remains active until the internal sample of incoming data is completed. Input data can be removed when either the read strobe or SDBEN becomes no longer active.

Figure 28. 68xxx-Mode DMA Write-Cycle Timing

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68xxx-mode bus-arbitration timing, SIF returns control

NO.		25-MHz OPERATION		25-MHz OPERATION		UNIT
		MIN	MAX	MIN	MAX	
220†	Delay time, SBCLK low in I1 cycle to SAD, SPL, SPH, $\overline{\text{SUDS}}$, and $\overline{\text{SLDS}}$ in the high-impedance state, bus release		35		35	ns
223b†	Delay time, SBCLK low in I1 cycle to SBHE/SRNW in the high-impedance state		45		45	ns
224b	Delay time, SBCLK low in cycle I2 to SOWN high	0	20	0	15	ns
224d	Delay time, SBCLK low in cycle I2 to SDDIR high		27		22	ns
230	Delay time, SBCLK high to either SHRQ low or SBRQ high		20		15	ns
240†	Setup from, SUDS, SLDS, SRNW, and SAS control signals in the high-impedance state before SOWN no longer low	0		0		ns

[†] This specification has been characterized to meet stated value. It is not assured during manufacturing testing.





[†] In 80x8x mode, the system interface deasserts SHRQ on the rising edge of SBCLK following the T4 state of the last system bus transfer it controls. In 68xxx mode, the system interface deasserts SBRQ on the rising edge of SBCLK in state T2 of the first system bus transfer it controls.

Figure 29. 68xxx-Mode Bus-Arbitration Timing, SIF Returns Control

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68xxx-mode bus-release and error timing

NO.	NO.		25-MHz OPERATION		33-MHz OPERATION	
			MAX	MIN	MAX	
208a	Setup time, asynchronous input before SBCLK no longer high to assure recognition	10		10		ns
208b	Hold time, asynchronous input SBRLS, SOWN, or SBERR after SBCLK low to assure recognition	10		10		ns
208c	Hold time, SBRLS low after SOWN high	0		0		ns
236	Setup time, SBERR low before SDTACK no longer high if parameter 208a not met	30		30		ns



- NOTES: A. The system interface ignores the assertion of SBRLS if it does not own the system bus. If it does own the bus, when it detects the assertion of SBRLS, it completes any internally started DMA cycle and relinquishes control of the bus. If no DMA transfer has internally started, the system interface releases the bus before starting another.
 - B. If SBERR is asserted when the system interface controls the system bus, the current bus transfer is completed regardless of the value of SDTACK. If the BERETRY register is nonzero, the cycle is retried. If the BERETRY register is zero, the system interface releases control of the system bus. The system interface ignores the assertion of SBERR if it is not performing a DMA bus cycle on the system bus. When SBERR is properly asserted and BERETRY is zero, the system interface releases the bus upon completion of the current bus transfer and halts all further DMA on the system side. The error is synchronized to the local bus, and DMA stops on the local sides. The value of the SDMAADR, SDMADDRX, and SDMALEN registers in the system interface are not defined after a system-bus error.
 - C. In cycle-steal mode, state TX is present on every system bus transfer. In burst mode, state TX is present on the first bus transfer and whenever the increment of the DMA address register carries beyond the least significant 16 bits.
 - D. SDTACK is not sampled to verify that it is deasserted.
 - E. Unless otherwise specified, for all signals specified as a maximum delay from the end of an SBCLK transition to the signal valid, the signal is also specified to hold its previous value (including high impedance) until the start of that SBCLK transition.

Figure 30. 68xxx-Mode Bus-Release and Error Timing



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Figure 31. 68xxx-Mode Bus Halt and Retry, Normal Completion With Delayed Start[†]

[†] Only the relative placement of the edges to SBCLK falling edge is shown. Actual signal edge placement can vary from waveforms shown.



Figure 32. 68xxx-Mode Bus Halt and Retry, Rerun Cycle With Delayed Start[†]

[†] Only the relative placement of the edges to SBCLK falling edge is shown. Actual signal edge placement can vary from waveforms shown.



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MECHANICAL DATA

PGE (S-PQFP-G144)

PLASTIC QUAD FLATPACK



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-136



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